VLSI Design

Introduction

Outline

- Introduction
- Silicon, pn-junctions and transistors
- A Brief History
- Operation of MOS Transistors
- CMOS circuits
- Fabrication steps for CMOS circuits

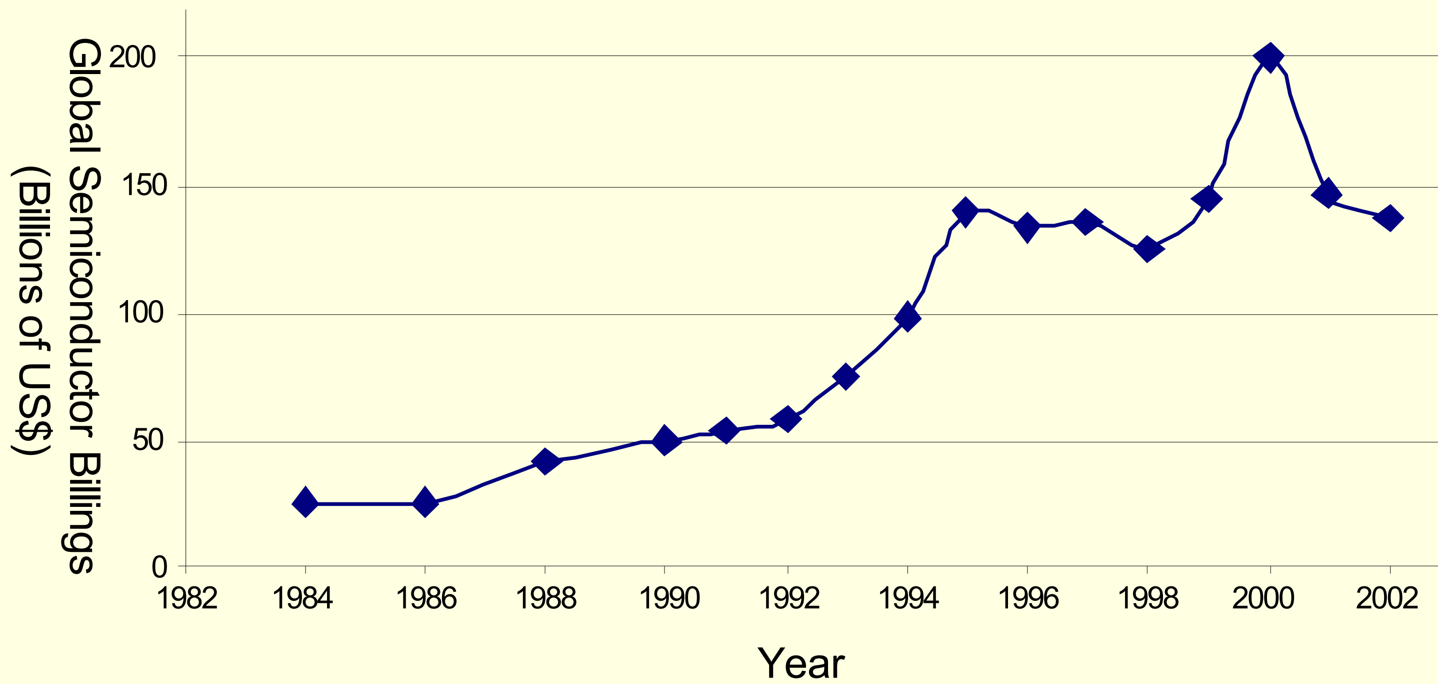
Introduction

- Integrated circuits: many transistors on one chip.
- *Very Large Scale Integration* (VLSI)
- *Complementary Metal Oxide Semiconductor* (CMOS)
  - Fast, cheap, “low-power” transistors circuits

Money, technology, civilization

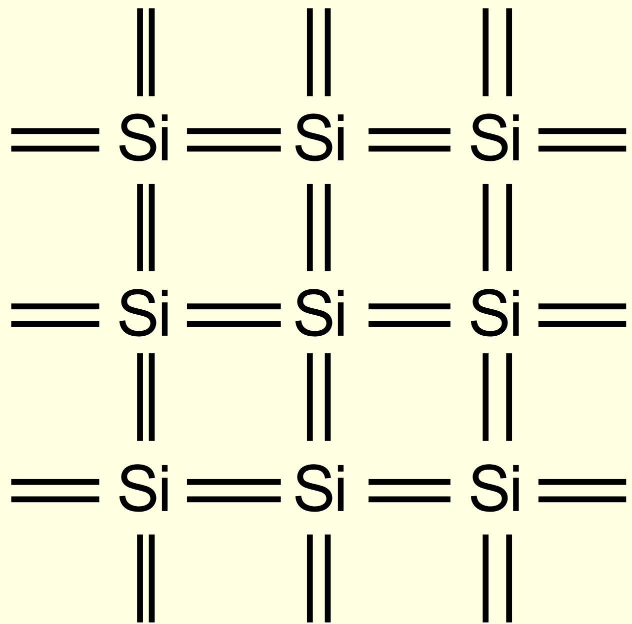
Annual Sales

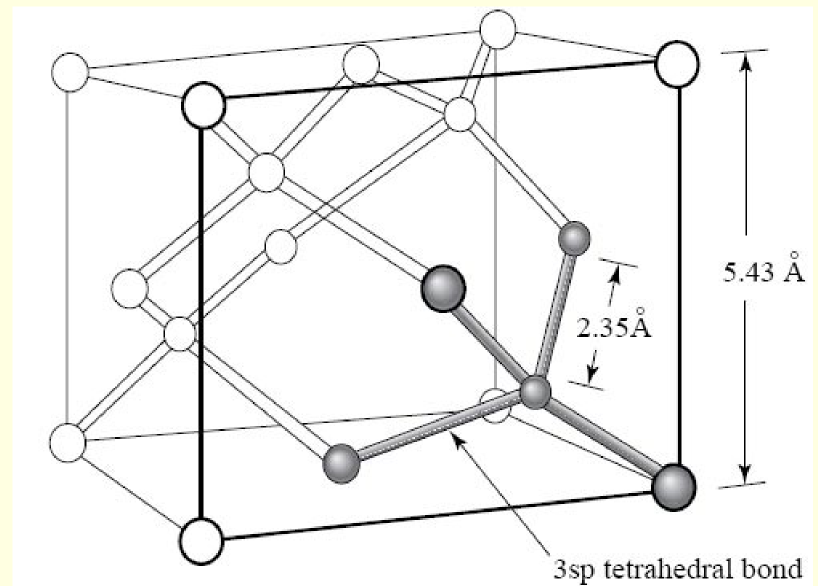
- 10^{18} transistors manufactured in 2003
  - 100 million for every human on the planet



Digression: Silicon Semiconductors

- Modern electronic chips are built mostly on silicon substrates
- Silicon is a Group IV semiconducting material
- crystal lattice: covalent bonds hold each atom to four neighbors

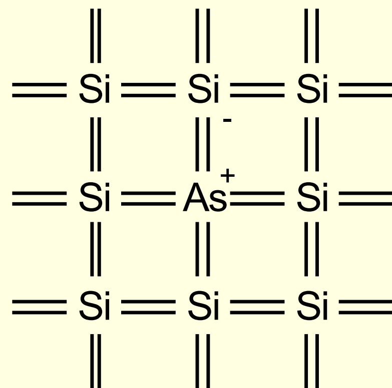


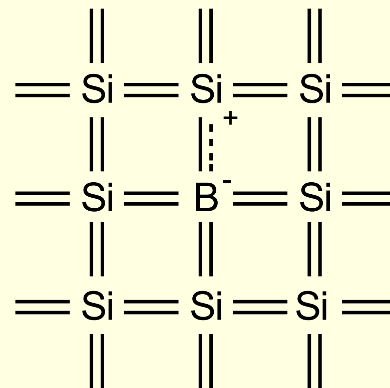


http://onlineheavytheory.net/silicon.html

Dopants

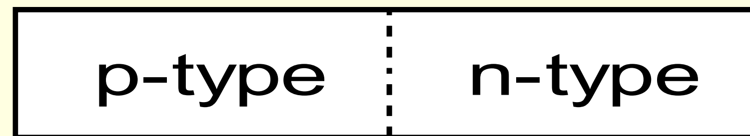
- Silicon is a semiconductor at room temperature
- Pure silicon has few free carriers and conducts poorly
- Adding dopants increases the conductivity drastically
- Dopant from Group V (e.g. As, P): extra electron (n-type)
- Dopant from Group III (e.g. B, Al): missing electron, called hole (p-type)



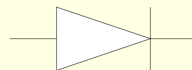


p-n Junctions

- First semiconductor (two terminal) devices
- A junction between p-type and n-type semiconductor forms a diode.
- Current flows only in one direction

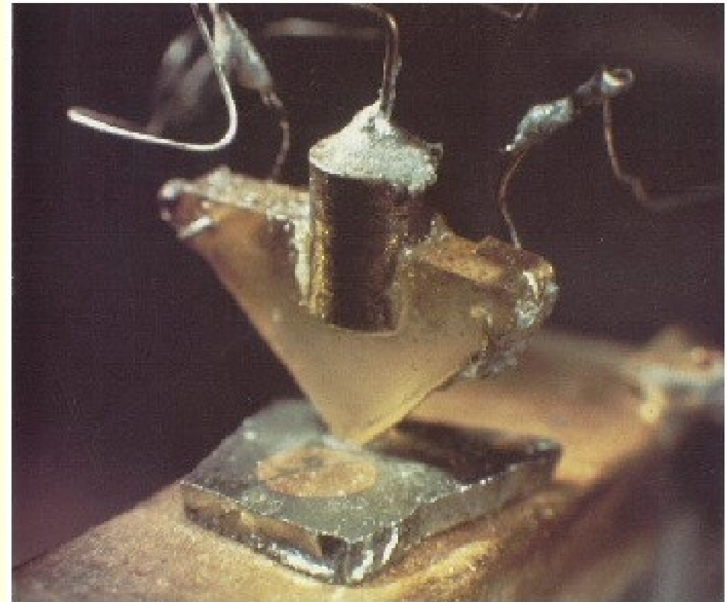


anode cathode



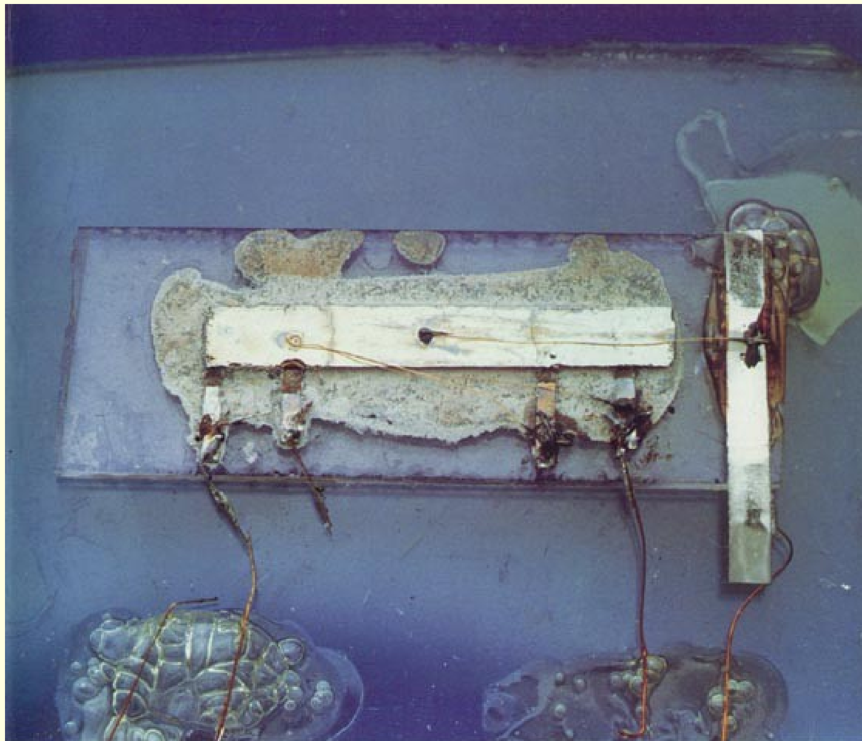
A Brief History
Invention of the Transistor

- Vacuum tubes ruled in first half of 20th century Large, expensive, power-hungry, unreliable
- 1947: first point contact transistor (3 terminal devices)
  - Shockley, Bardeen and Brattain at Bell Labs



A Brief History, contd..

- 1958: First integrated circuit
  - Flip-flop using two transistors
  - Built by Jack Kilby (Nobel Laureate) at Texas Instruments
  - Robert Noyce (Fairchild) is also considered as a co-inventor

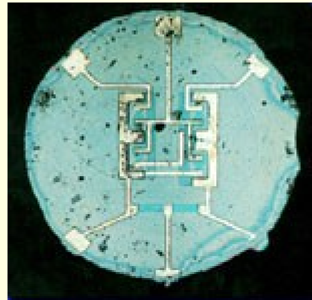


Kilby's IC

smithsonianchips.si.edu/ augarten/

A Brief History, contd.

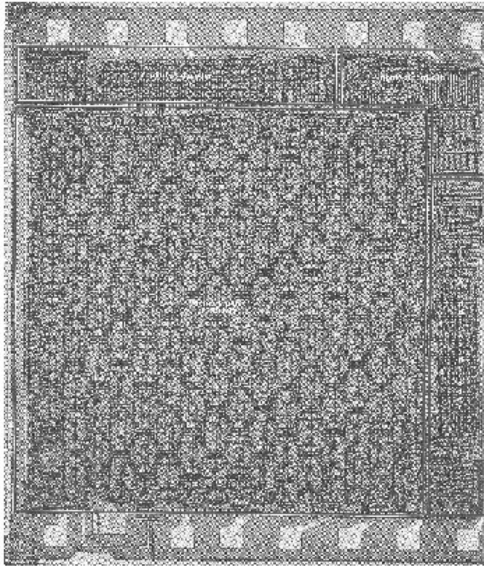
- First Planer IC built in 1961

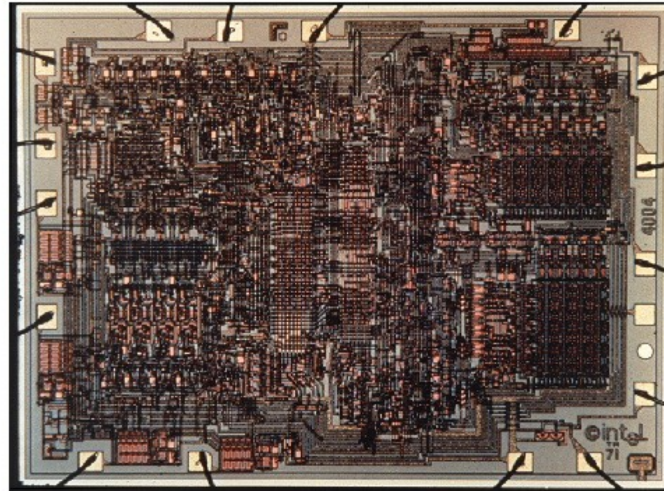


- 2003
  - Intel Pentium 4 μprocessor (55 million transistors)
  - 512 Mbit DRAM (> 0.5 billion transistors)
- 53% compound annual growth rate over 45 years
  - No other technology has grown so fast so long
- Driven by miniaturization of transistors
  - Smaller is cheaper, faster, lower in power!
  - Revolutionary effects on society

MOS Integrated Circuits

- 1970's processes usually had only nMOS transistors
  - Inexpensive, but consume power while idle
- 1980s-present: CMOS processes for low idle power

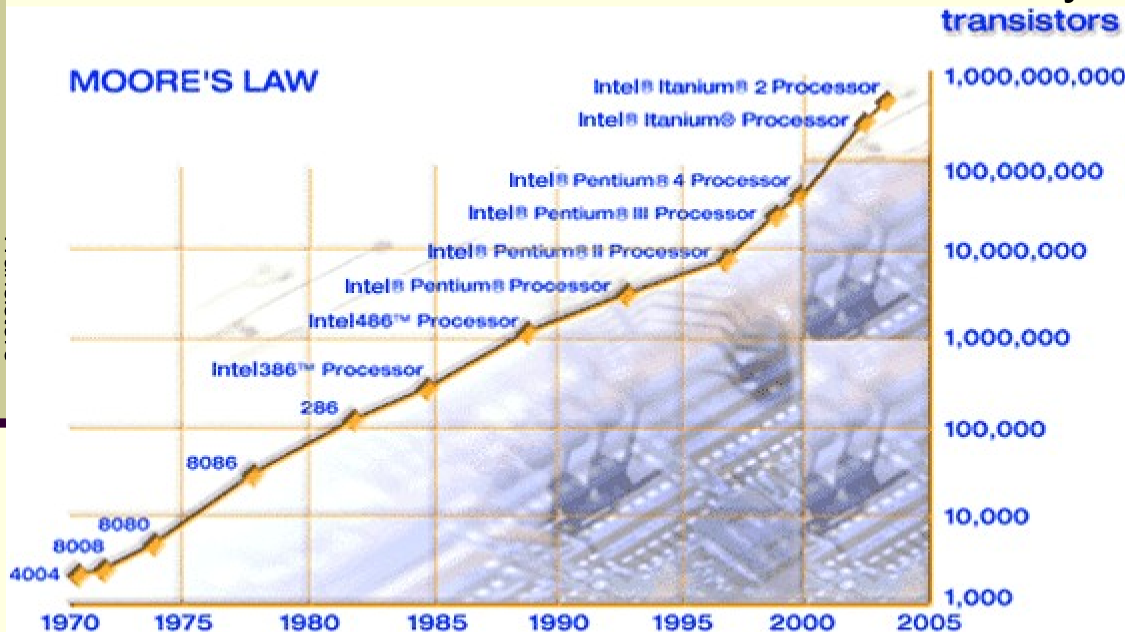




Intel 1101 256-bit SRAM   Intel 4004 4-bit μProc

Moore’s Law

- 1965: Gordon Moore plotted transistor on each chip
  - Fit straight line on semilog scale
  - Transistor counts have doubled every 26 months



Integration Levels

SSI: 10 gates

MSI: 1000 gates

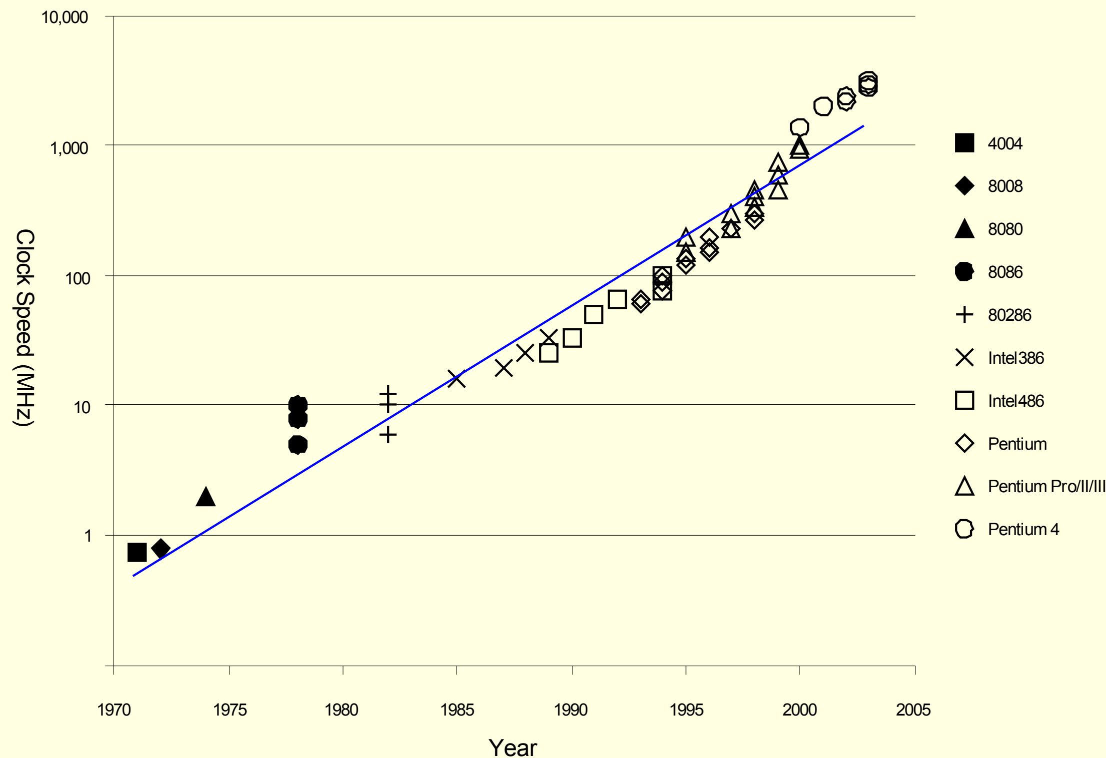
LSI: 10,000 gates

VLSI: > 10k gates

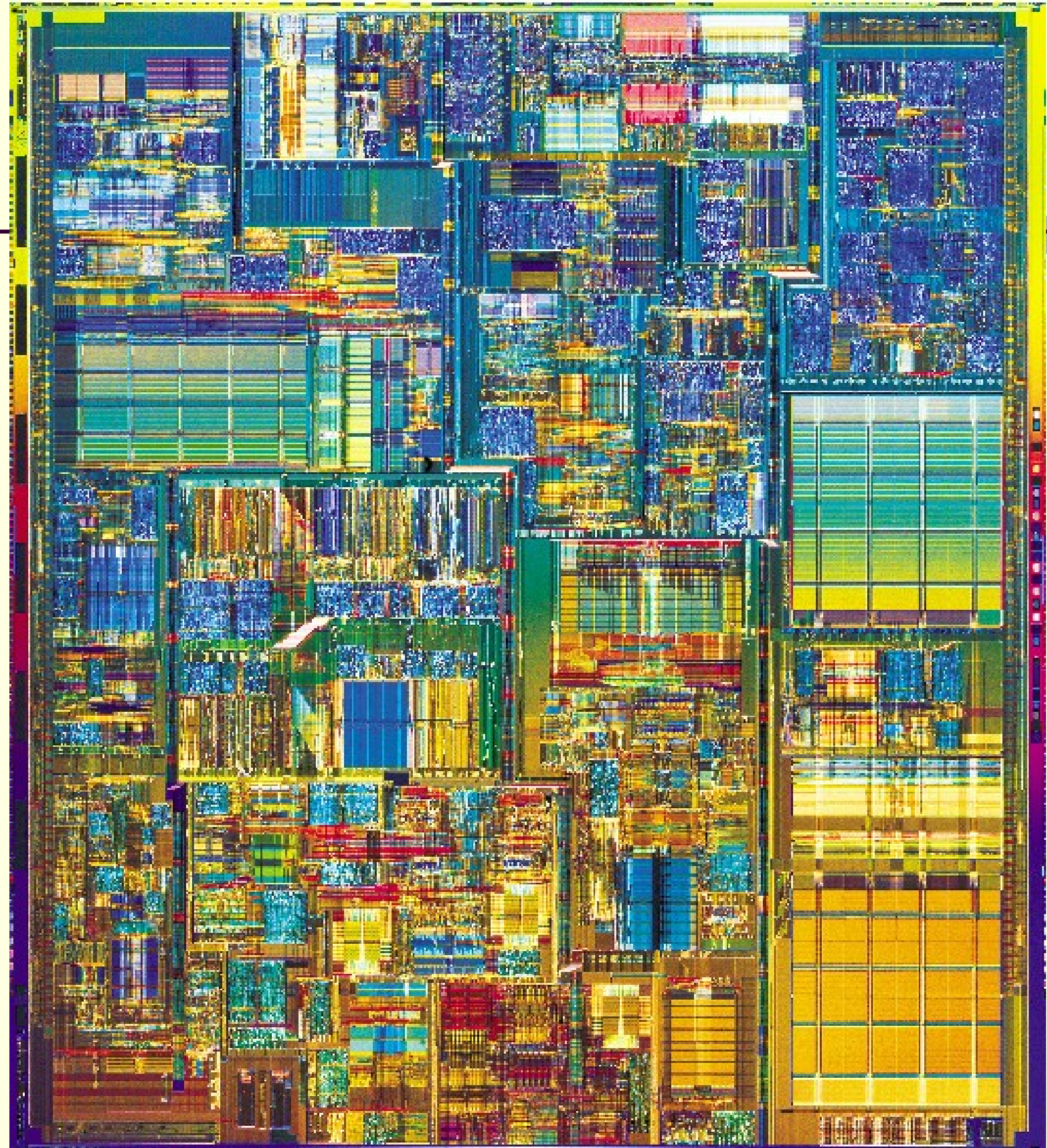
http://www.intel.com/technology/silicon/mooreslaw/

Corollaries

- Many other factors grow exponentially
  - Ex: clock frequency, processor performance



Pentium 4 Processor



http://www.intel.com/intel/intelis/museum/online/hist_micro/hof/index.htm

- Modern transistors are few microns wide and approximately 0.1 micron or less in length
- Human hair is 80-90 microns in diameter

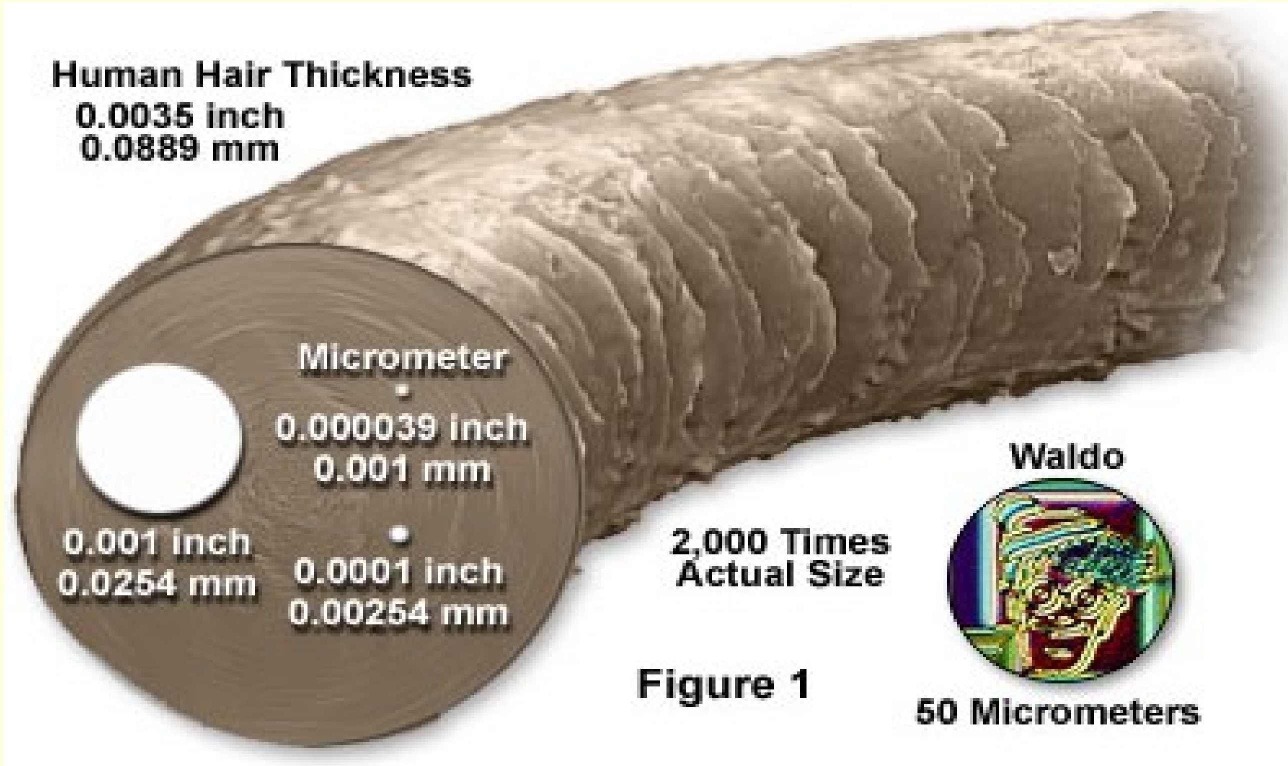


Figure 1

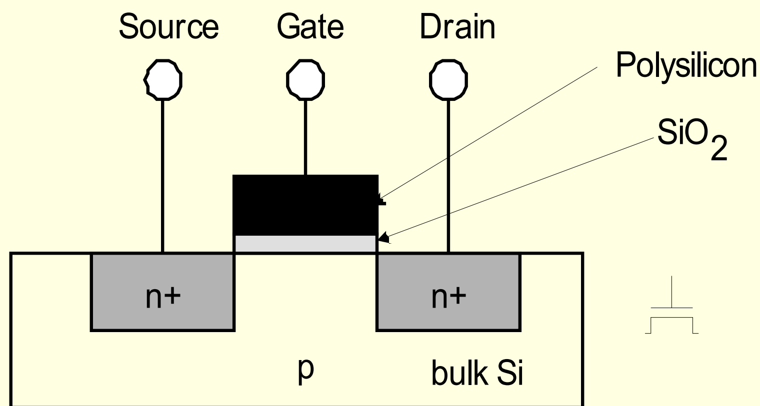
Ref: http://micro.magnet.fsu.edu/creatures/technical/sizematters.html

Transistor Types

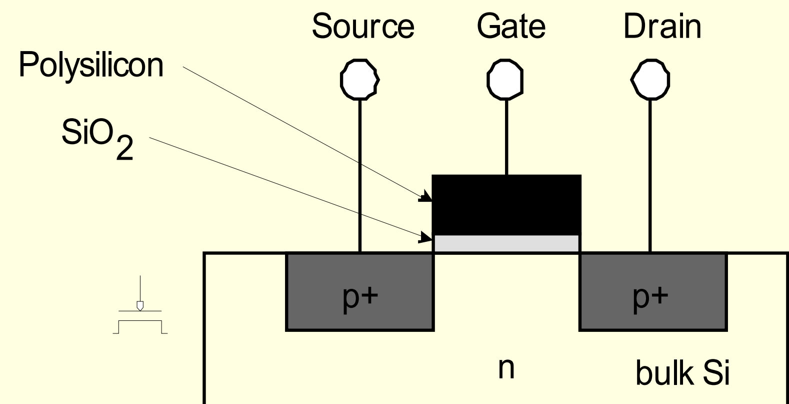
- Bipolar transistors
  - npn or pnp silicon structure
  - Small current into very thin base layer controls large currents between emitter and collector
  - Base currents limit integration density
- Metal Oxide Semiconductor Field Effect Transistors
  - nMOS and pMOS MOSFETS
  - Voltage applied to insulated gate controls current between source and drain
  - Low power allows very high integration
  - First patent in the ’20s in USA and Germany
  - Not widely used until the ’60s or ’70s

MOS Transistors

- Four terminal device: gate, source, drain, body
- Gate – oxide – body stack looks like a capacitor
  - Gate and body are conductors (body is also called the substrate)
  - SiO_2 (oxide) is a "good" insulator (separates the gate from the body
  - Called metal–oxide–semiconductor (MOS) capacitor, even though gate is mostly made of poly-crystalline silicon (polysilicon)



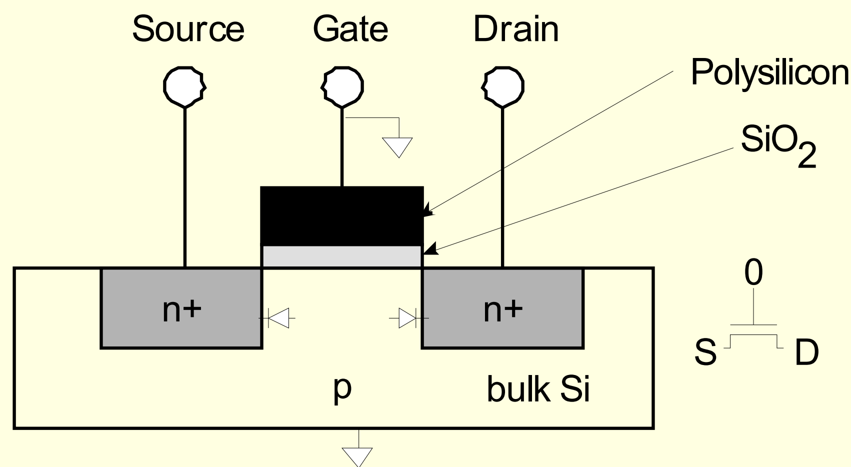
NMOS



PMOS

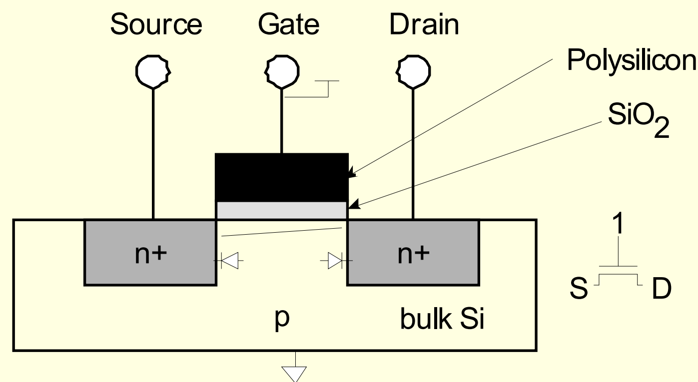
NMOS Operation

- Body is commonly tied to ground (0 V)
- Drain is at a higher voltage than Source
- When the gate is at a low voltage:
  - P-type body is at low voltage
  - Source-body and drain-body “diodes” are OFF
  - No current flows, transistor is OFF



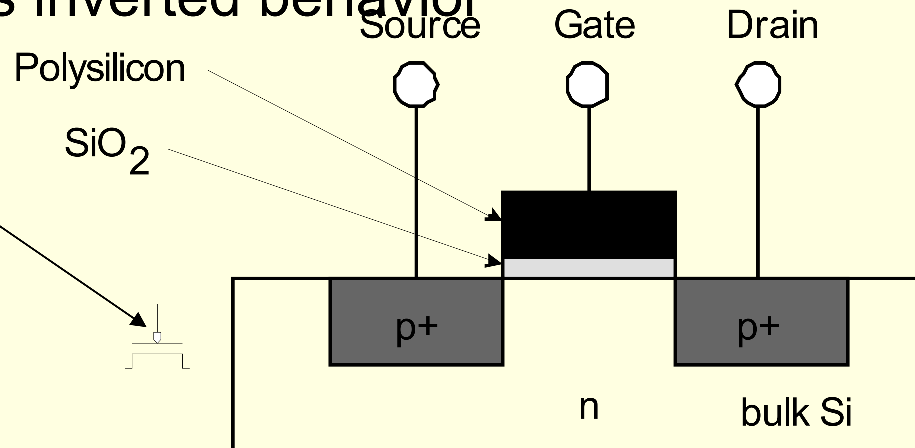
NMOS Operation Cont.

- When the gate is at a high voltage: Positive charge on gate of MOS capacitor
  - Negative charge is attracted to body under the gate
  - Inverts a channel under gate to "n-type" (N-channel, hence called the NMOS) if the gate voltage is above a threshold voltage (VT)
  - Now current can flow through "n-type" silicon from source through channel to drain, transistor is ON



PMOS Transistor

- Similar, but doping and voltages reversed
  - Body tied to high voltage (V_{DD})
  - Drain is at a lower voltage than the Source
  - Gate low: transistor ON
  - Gate high: transistor OFF
  - Bubble indicates inverted behavior



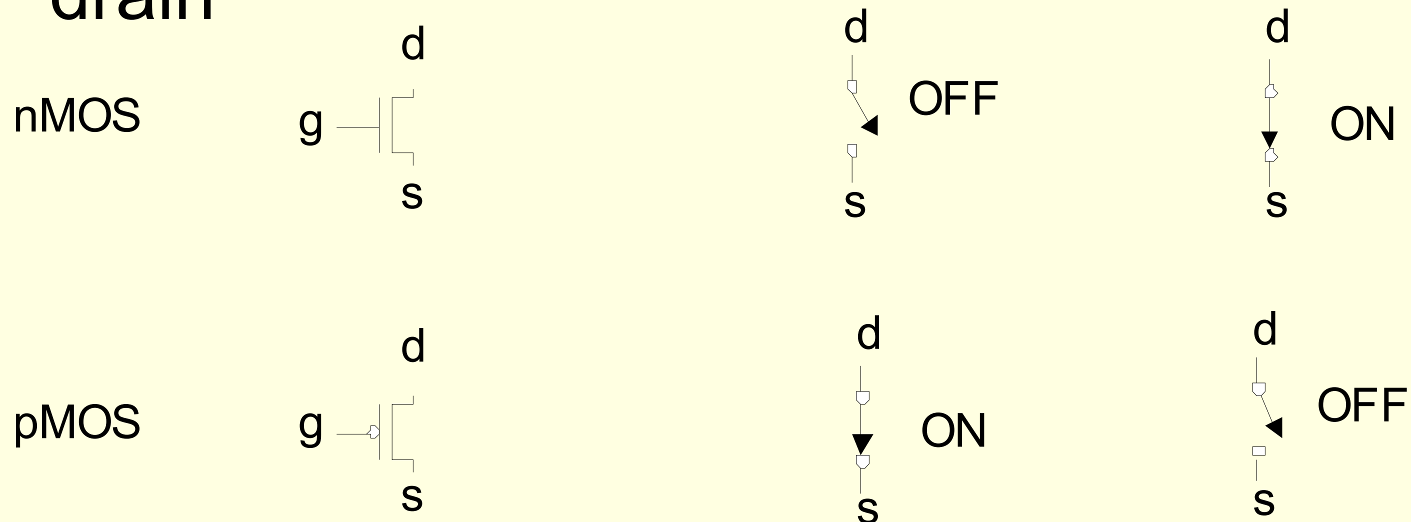
Power Supply Voltage

- GND = 0 V
- In 1980's, V_{DD} = 5V
- V_{DD} has decreased in modern processes
  - High V_{DD} would damage modern tiny transistors
  - Lower V_{DD} saves power
- V_{DD} = 3.3, 2.5, 1.8, 1.5, 1.2, 1.0,
- Effective power supply voltage can be lower due

  to IR drop across the power grid.

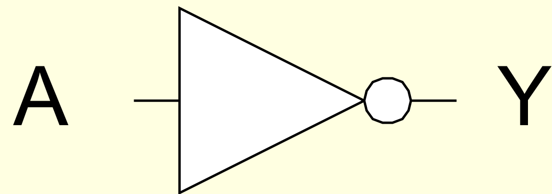
Transistors as Switches

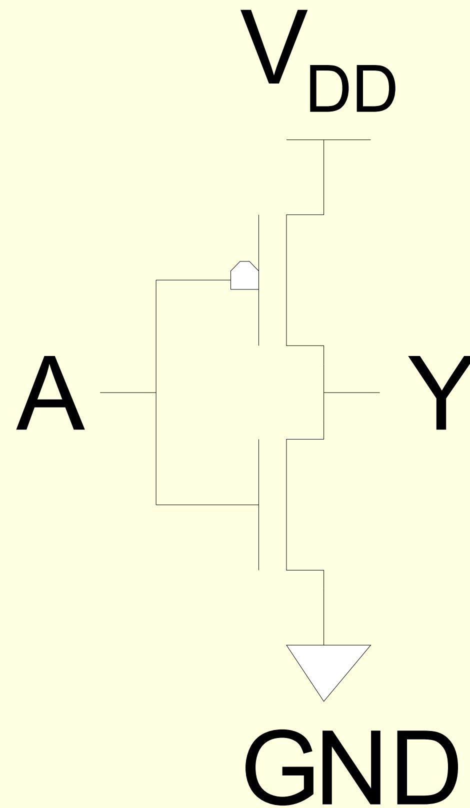
- In Digital circuits, MOS transistors are electrically controlled switches
- Voltage at gate controls path from source to drain



CMOS Inverter

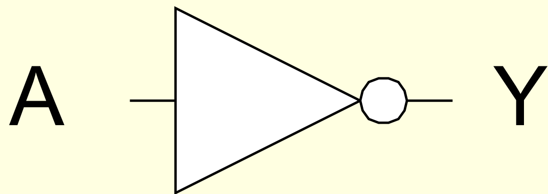
A	Y
0	
1	

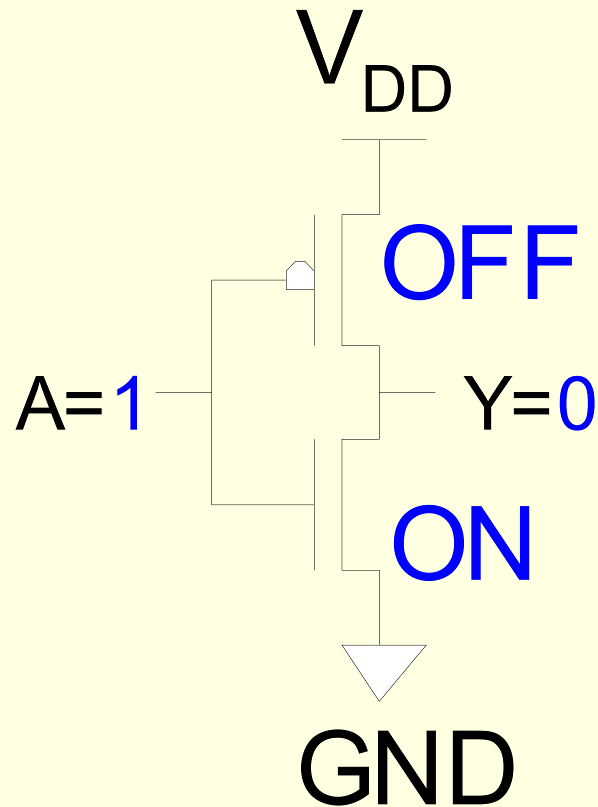




CMOS Inverter

A	Y
0	
1	**0**

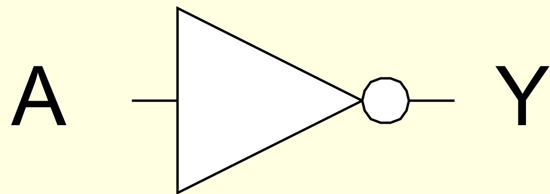


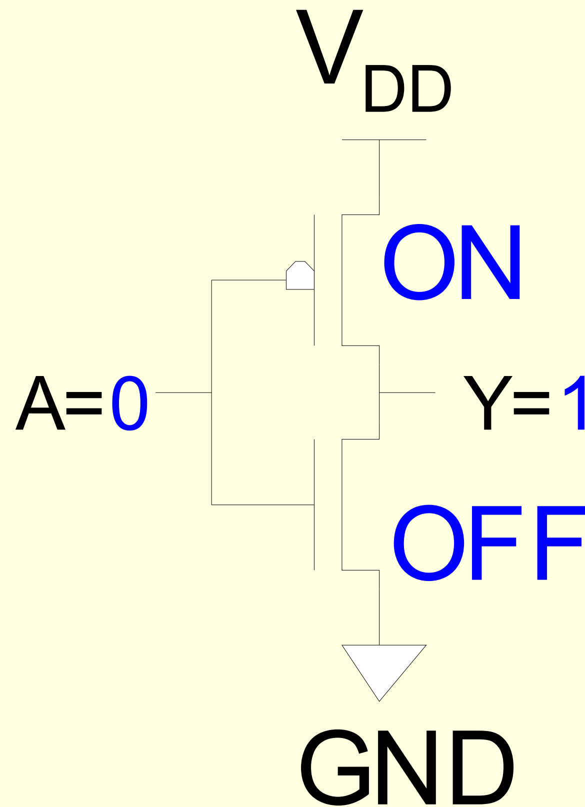


Y is pulled low by the turned on NMOS Device. Hence NMOS is the pull-down device.

CMOS Inverter

A	Y
0	**1**
1	0

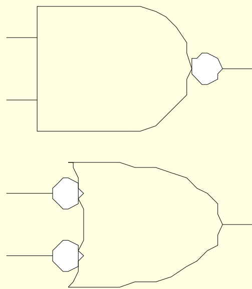


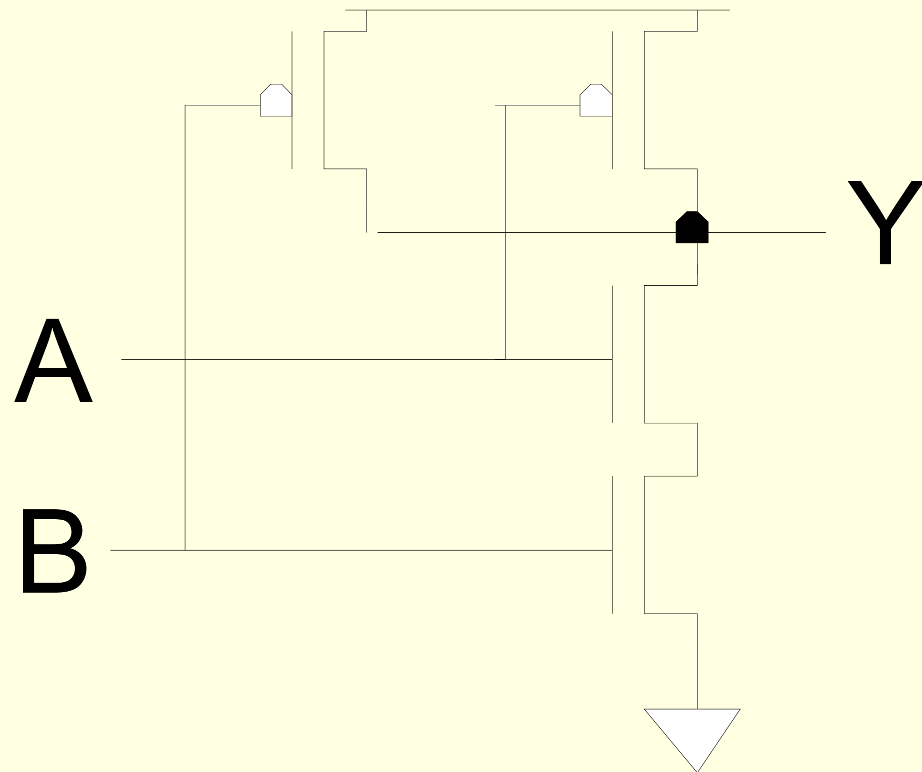


Y is pulled high by the turned on PMOS Device. Hence PMOS is the pull-up device.

CMOS NAND Gate

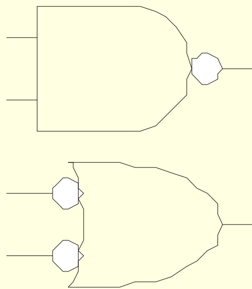
A	B	Y
0	0	
0	1	
1	0	
1	1	

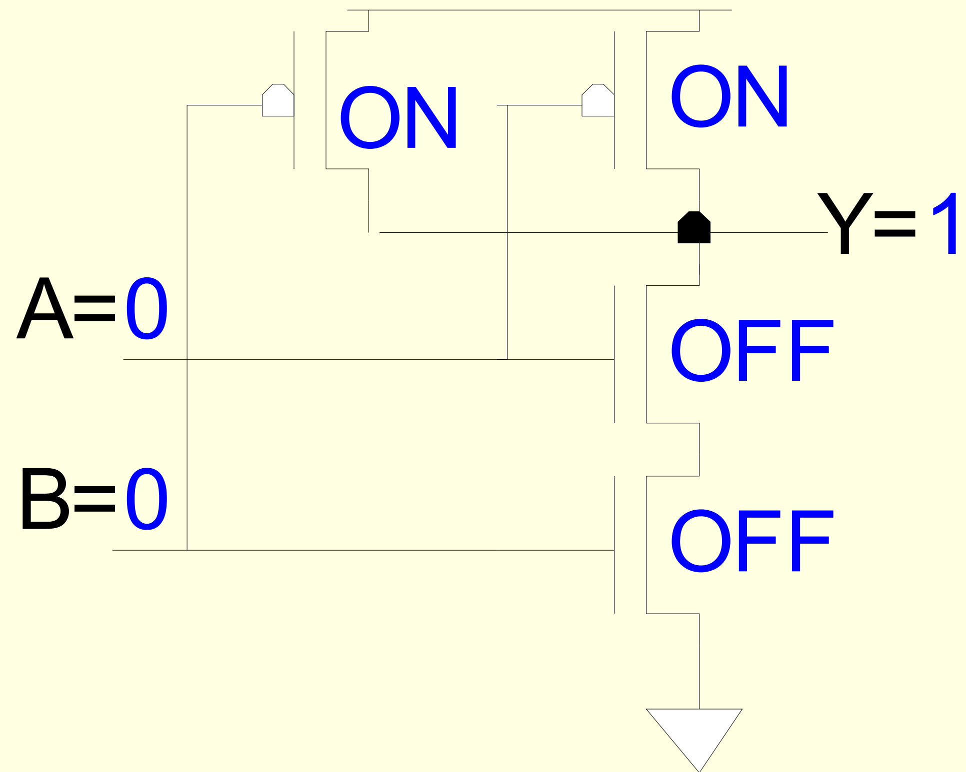




CMOS NAND Gate

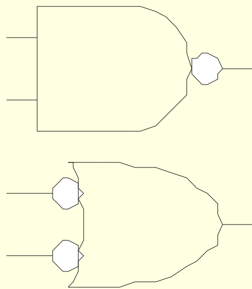
A	B	Y
0	**0**	**1**
0	1	
1	0	
1	1	

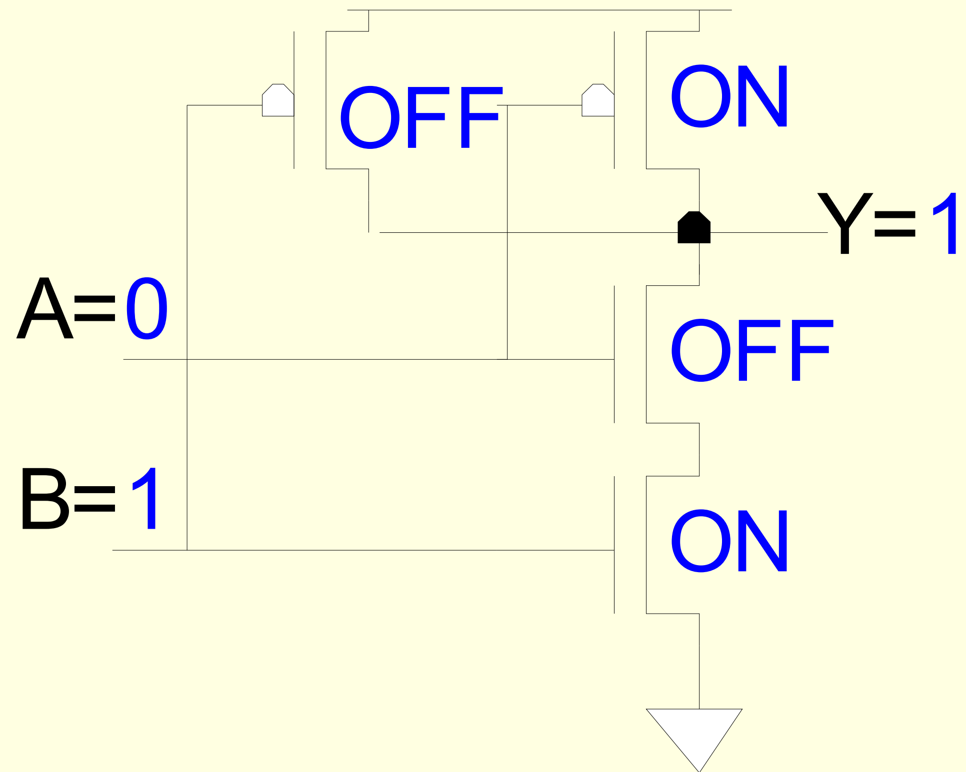




CMOS NAND Gate

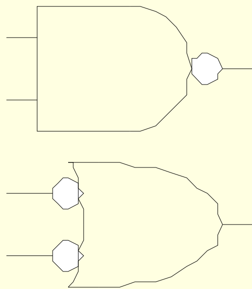
A	B	Y
0	0	1
0	**1**	**1**
1	0	
1	1	

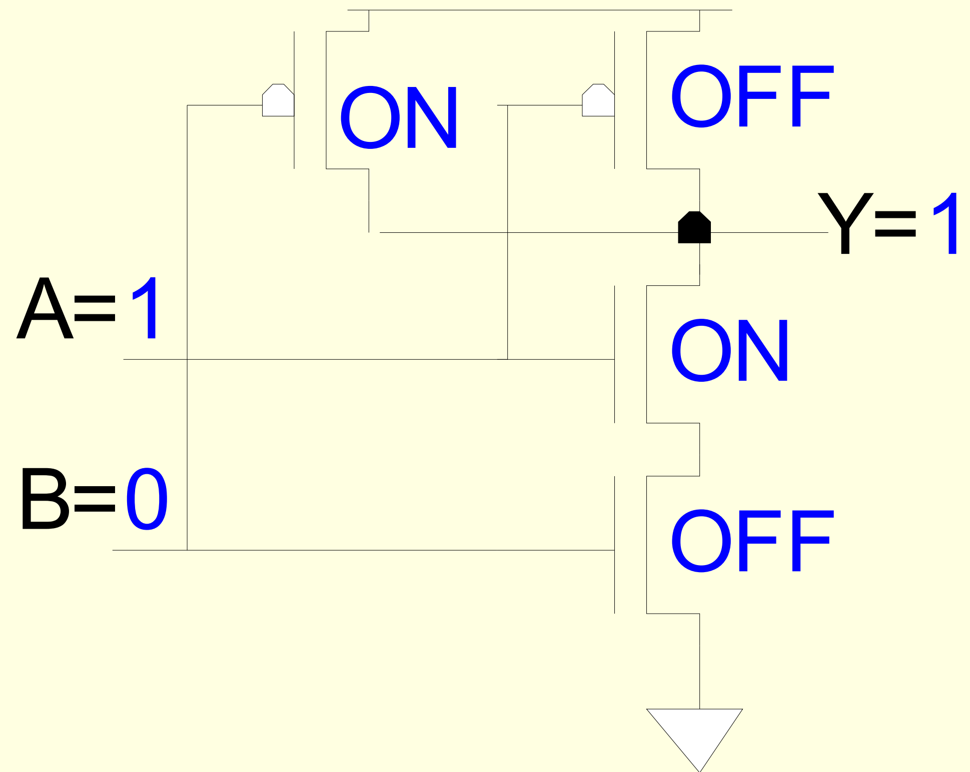




CMOS NAND Gate

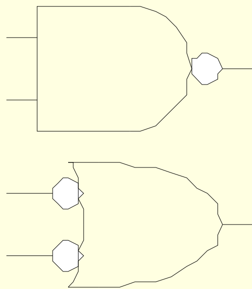
A	B	Y
0	0	1
0	1	1
1	**0**	**1**
1	1	

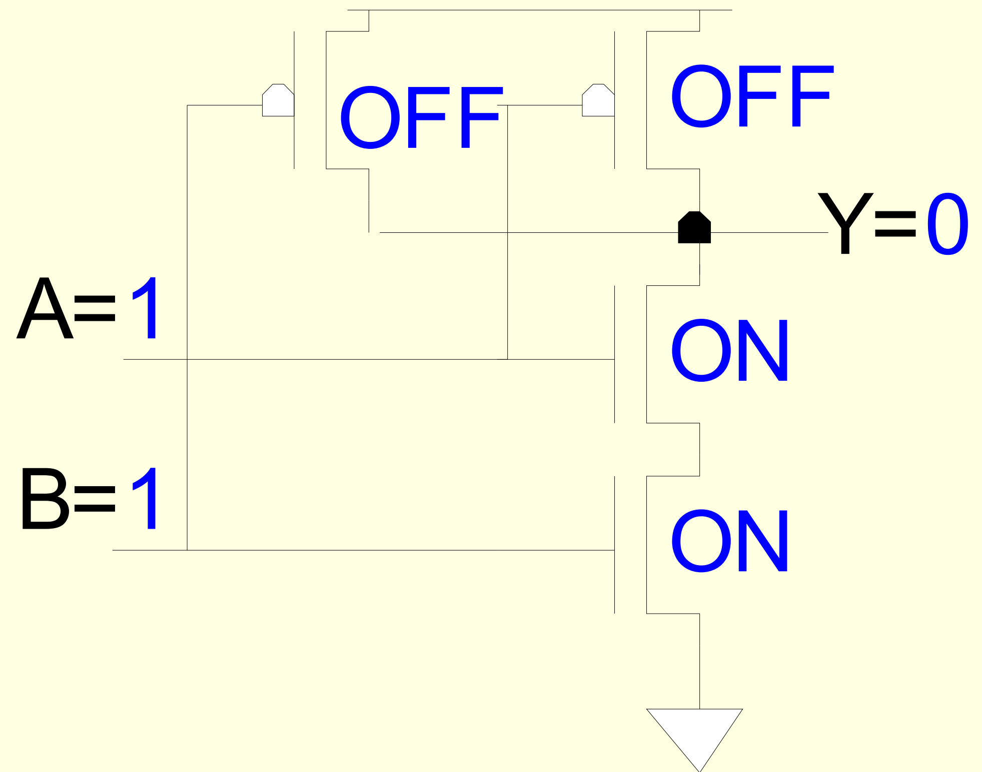




CMOS NAND Gate

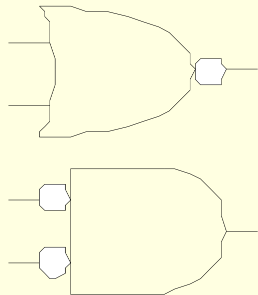
A	B	Y
0	0	1
0	1	1
1	0	1
1	**1**	**0**

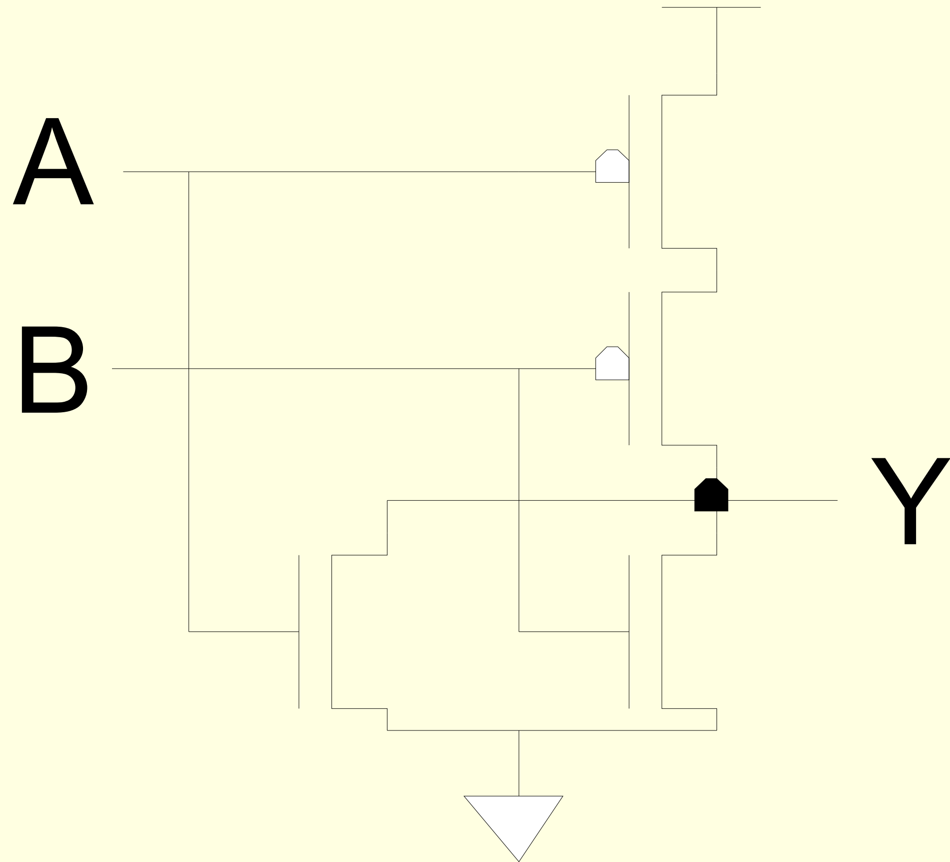




CMOS NOR Gate

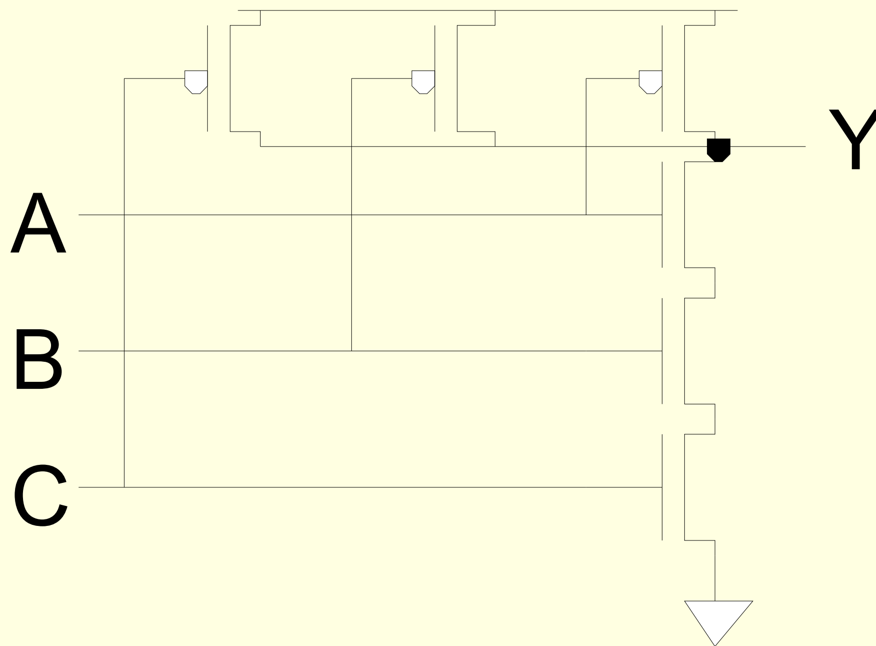
A	B	Y
0	0	1
0	1	0
1	0	0
1	1	0





3-input NAND Gate

- Y is pulled low if ALL inputs are 1
- Y is pulled high if ANY input is 0

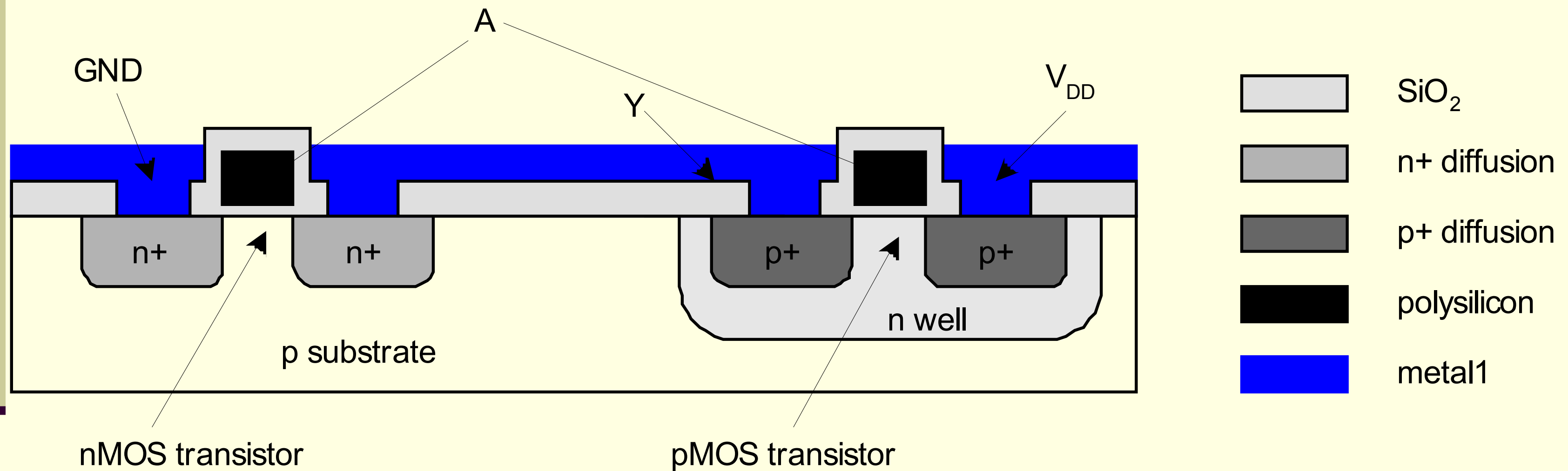


CMOS Fabrication

- CMOS transistors are fabricated on silicon wafer
- Wafers diameters (200-300 mm)
- Lithography process similar to printing press
- On each step, different materials are deposited, or patterned or etched
- Easiest to understand by viewing both top and cross-section of wafer in a simplified manufacturing process

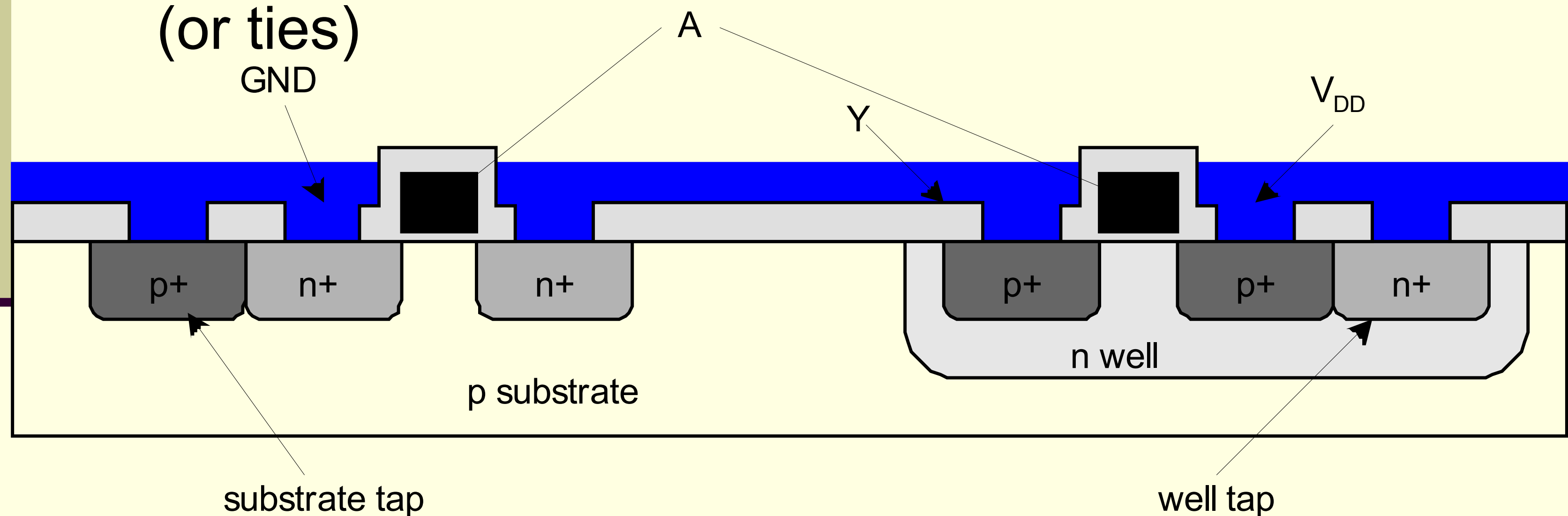
Inverter Cross-section

- Typically use p-type substrate for nMOS transistors
- Requires to make an n-well for body of pMOS transistors



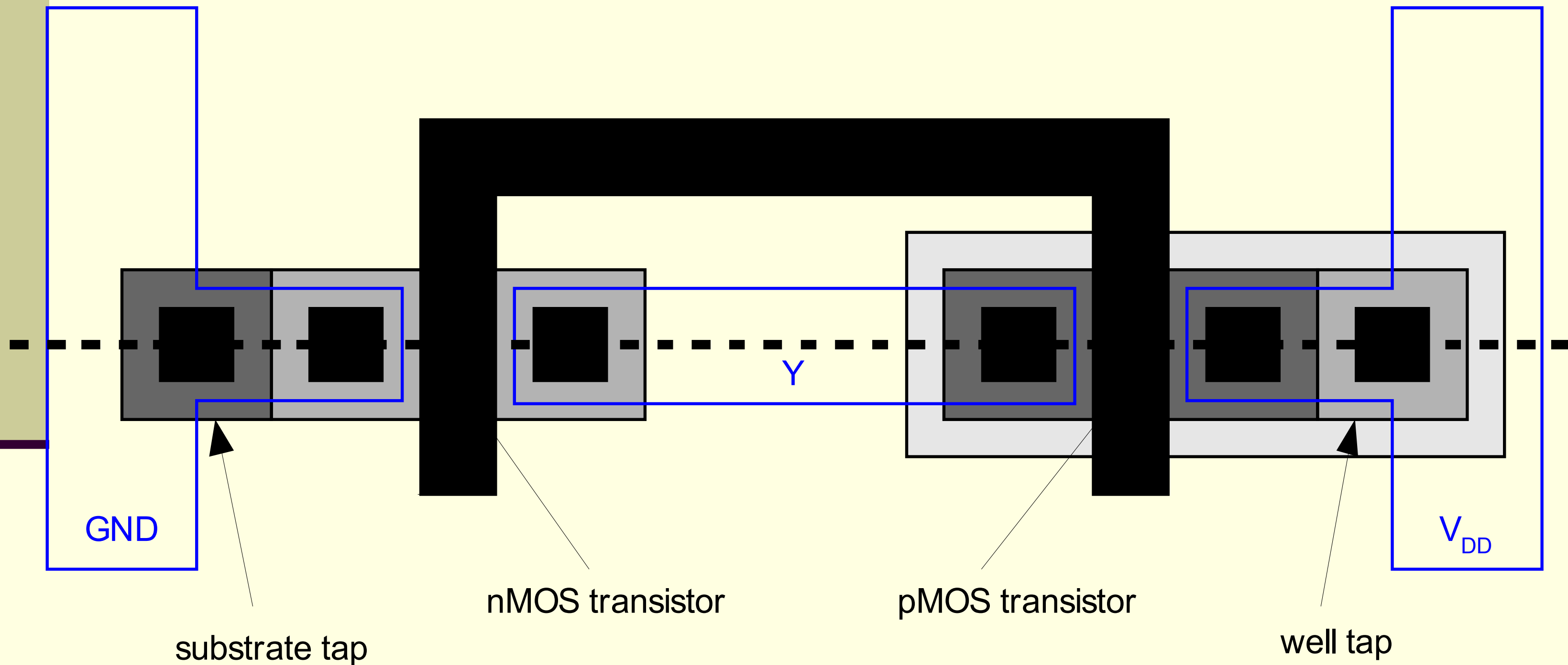
Well and Substrate Taps

- Substrate must be tied to GND and n-well to V_{DD}
- Metal to lightly-doped semiconductor forms poor connection called Schottky Diode
- Use heavily doped well and substrate contacts/taps (or ties)



Inverter Mask Set

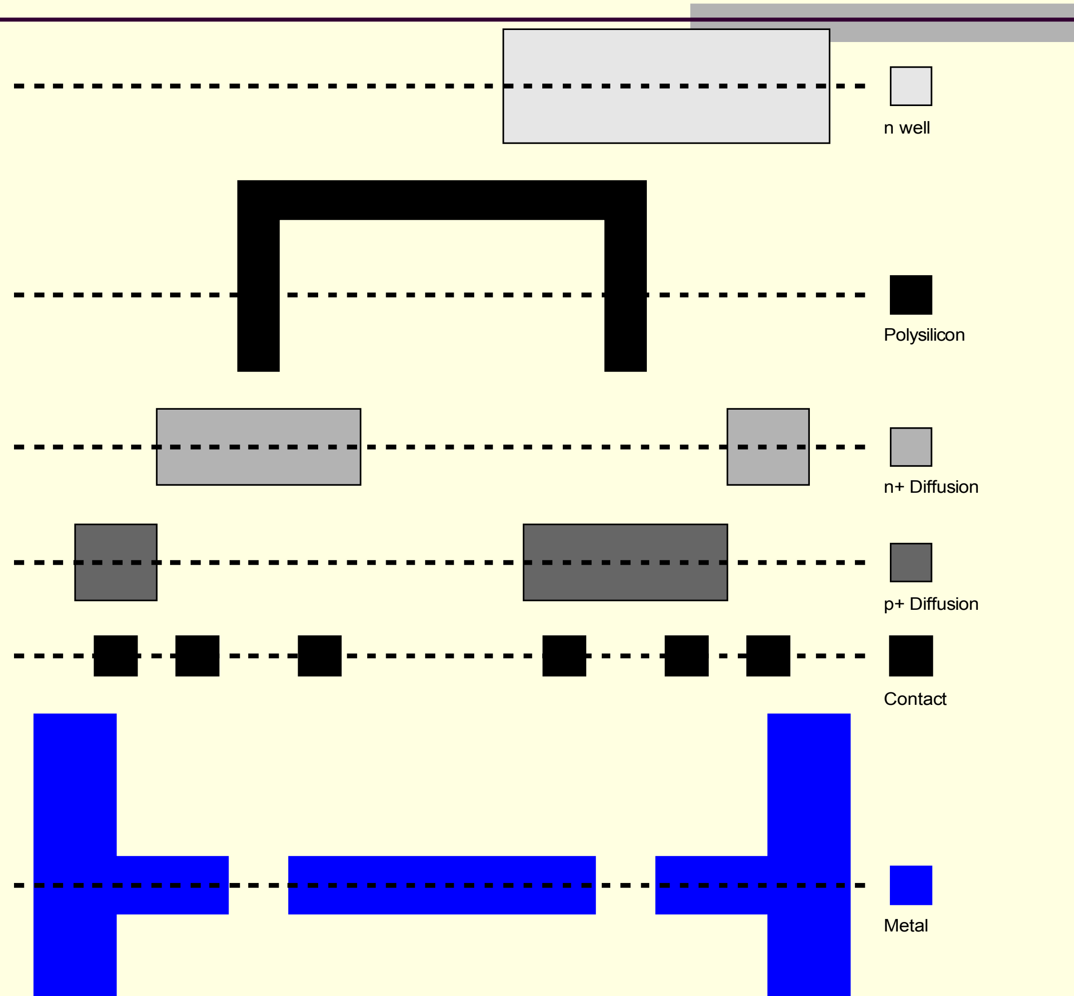
- Top view
- Transistors and wires are defined by *masks*
- Cross-section taken along dashed line



Detailed Mask Views

- Six masks
  - n-well
  - Polysilicon
  - n+ diffusion
  - p+ diffusion
  - Contact
  - Metal

In reality >40 masks may be needed



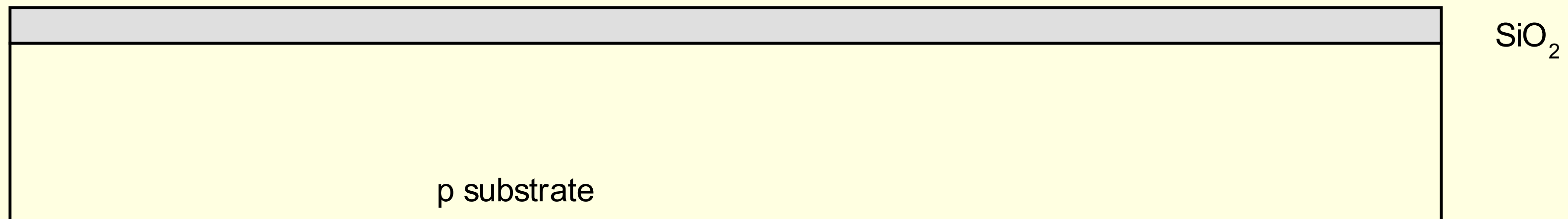
Fabrication Steps

- Start with blank wafer (typically p-type where NMOS is created)
- Build inverter from the bottom up
- First step will be to form the n-well (where PMOS would reside)
  - Cover wafer with protective layer of SiO_2 (oxide)
  - Remove oxide layer where n-well should be built
  - Implant or diffuse n dopants into exposed wafer to form n-well
  - Strip off SiO_2

p substrate

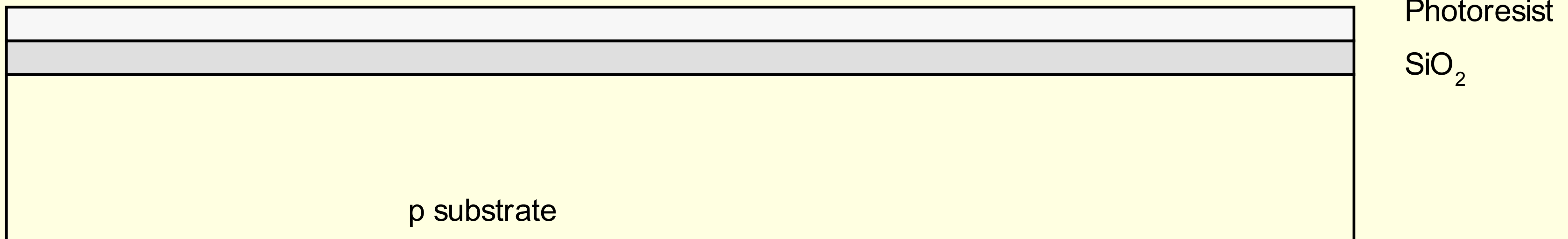
Oxidation

- Grow SiO_2 on top of Si wafer
  - 900 – 1200 C with H_2O or O_2 in oxidation furnace



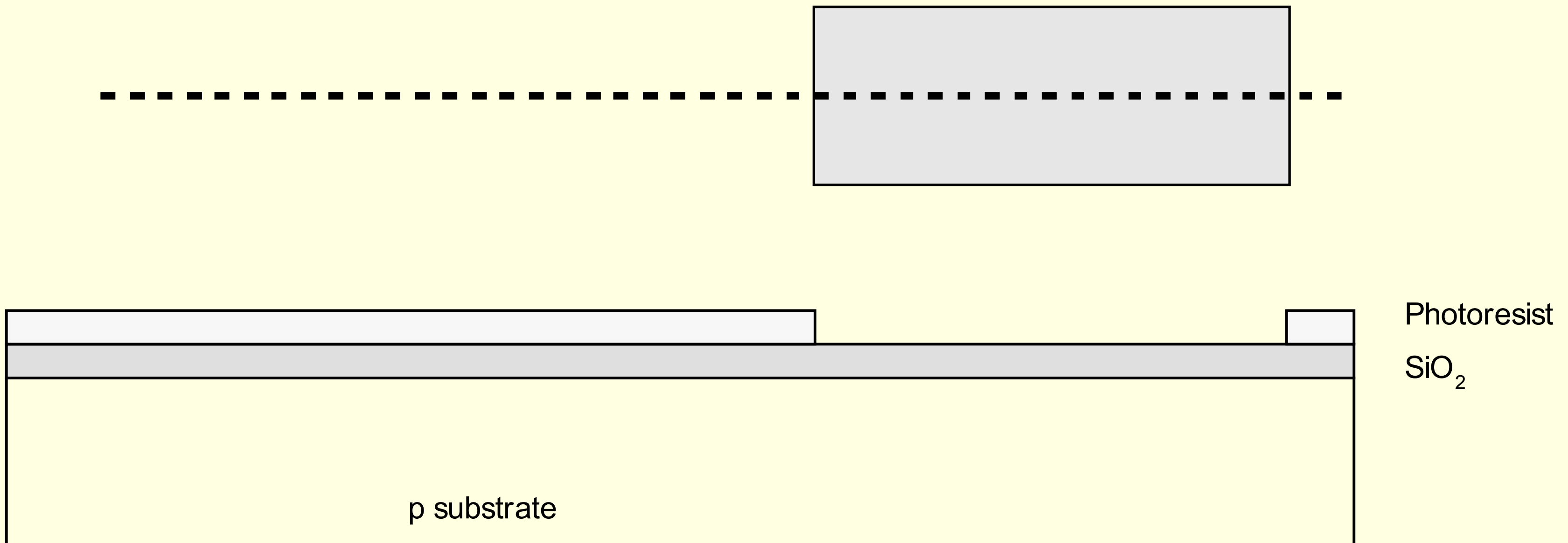
Photoresist

- Spin on photoresist
  - Photoresist is a light-sensitive organic polymer
  - Property changes where exposed to light
- Two types of photoresists (positive or negative)
  - Positive resists can be removed if exposed to UV light
  - Negative resists cannot be removed if exposed to UV light



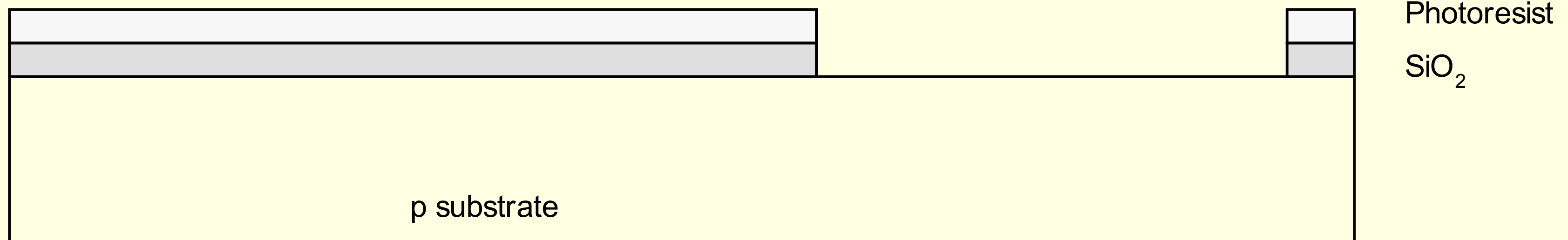
Lithography

- Expose photoresist to Ultra-violate (UV) light through the n-well mask
- Strip off exposed photoresist with chemicals



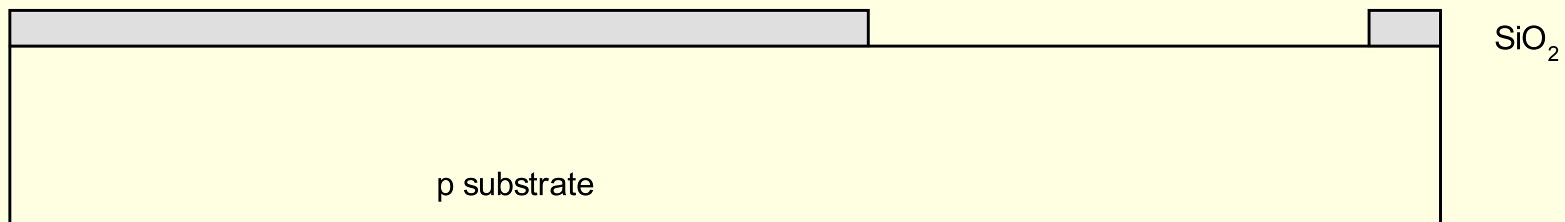
Etch

- Etch oxide with hydrofluoric acid (HF)
  - Seeps through skin and eats bone; nasty stuff!!!
- Only attacks oxide where resist has been exposed
- N-well pattern is transferred from the mask to silicon-di-oxide surface; creates an opening to the silicon surface



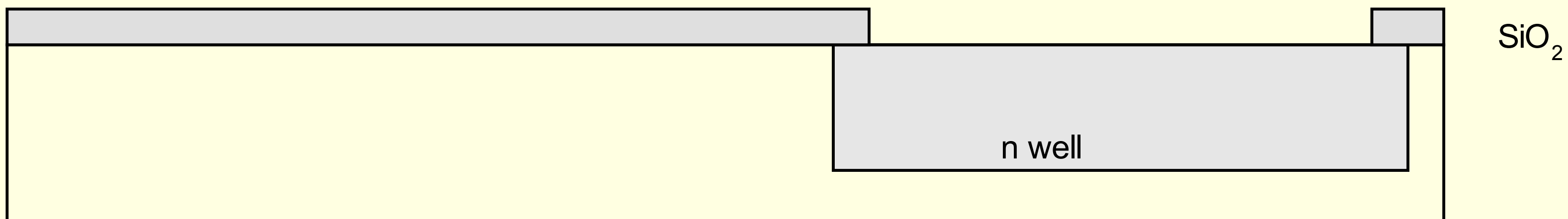
Strip Photoresist

- Strip off remaining photoresist
  - Use mixture of acids called piranah etch
- Necessary so resist doesn’t melt in next step



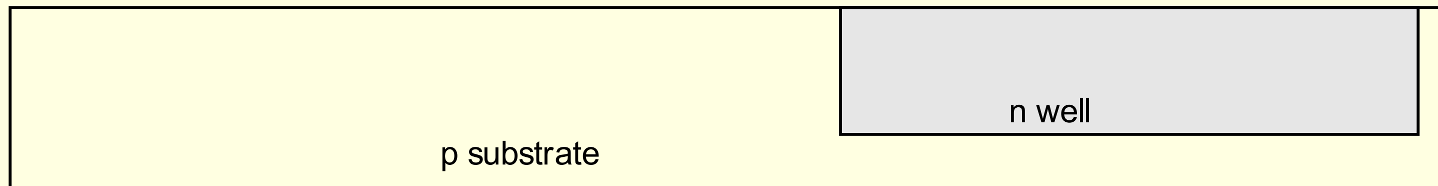
n-well

- n-well is formed with diffusion or ion implantation
- Diffusion
  - Place wafer in furnace with arsenic-rich gas
  - Heat until As atoms diffuse into exposed Si
- Ion Implanatation
  - Blast wafer with beam of As ions
  - Ions blocked by SiO_2, only enter exposed Si
- SiO_2 shields (or masks) areas which remain p-type



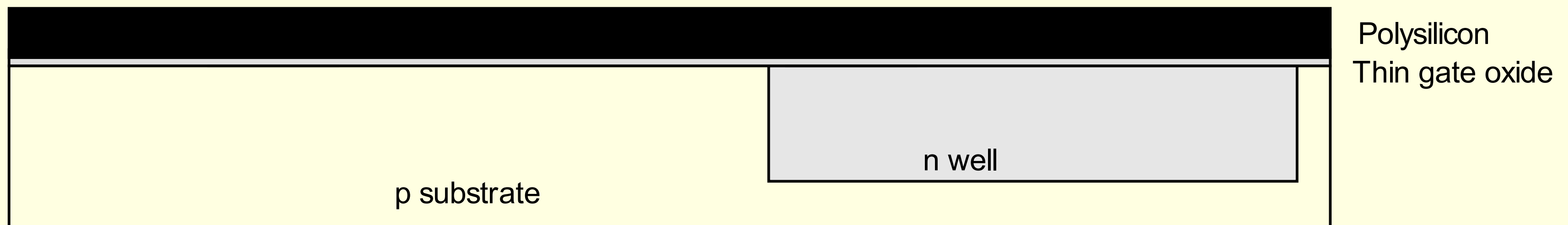
Strip Oxide

- Strip off the remaining oxide using HF
- Back to bare wafer with n-well
- Subsequent steps involve similar series of steps



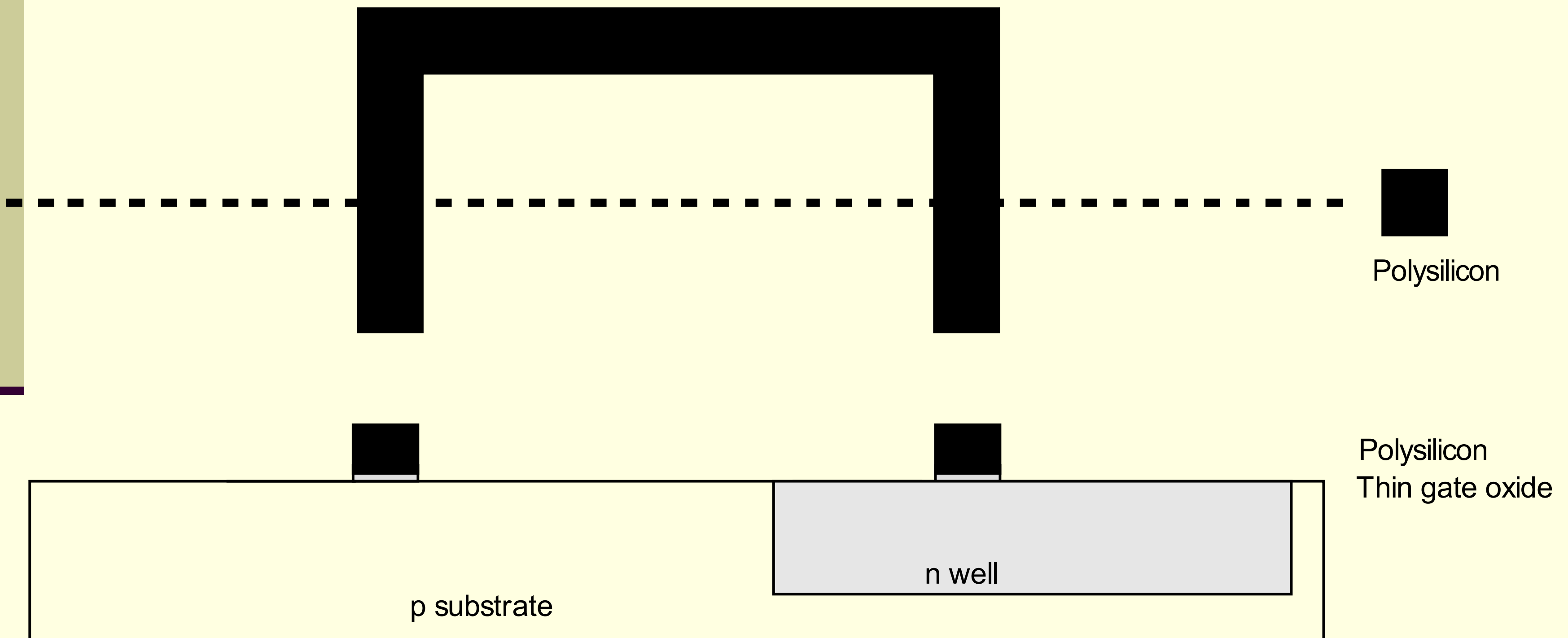
Polysilicon
(self-aligned gate technology)

- Deposit very thin layer of gate oxide
  - < 20 Å (6-7 atomic layers)
- Chemical Vapor Deposition (CVD) of silicon layer
  - Place wafer in furnace with Silane gas (SiH_4)
  - Forms many small crystals called polysilicon
  - Heavily doped to be good conductor



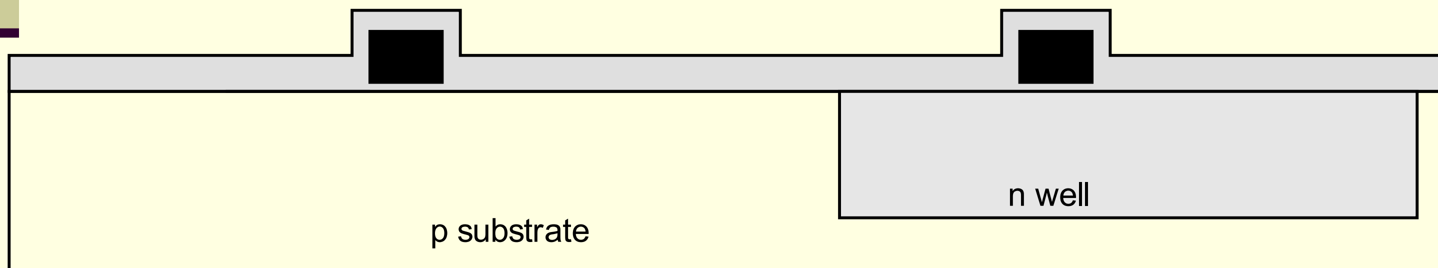
Polysilicon Patterning

- Use same lithography process discussed earlier to pattern polysilicon



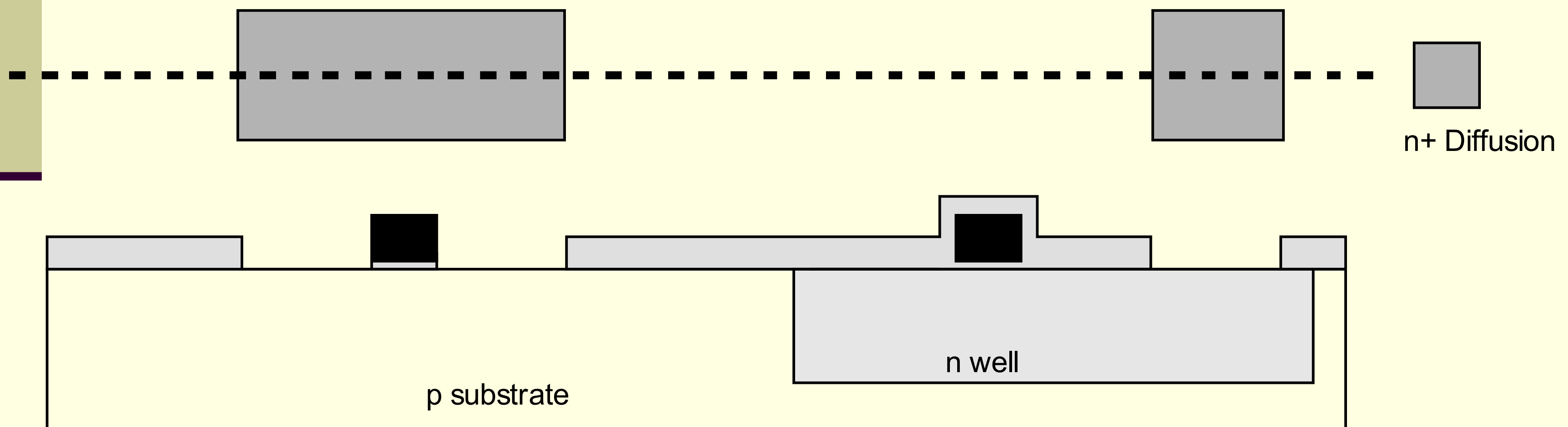
Self-Aligned Process

- Use gate-oxide/polysilicon and masking to expose where n+ dopants should be diffused or implanted
- N-diffusion forms nMOS source, drain, and n-well contact



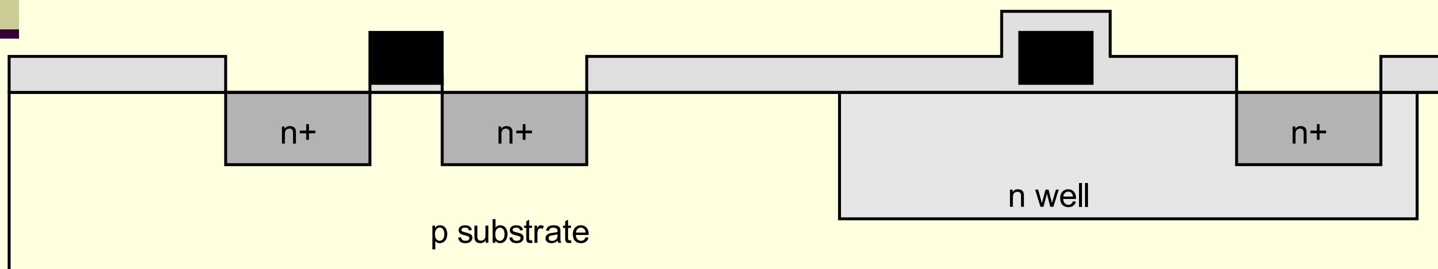
N-diffusion/implantation

- Pattern oxide and form n+ regions
- *Self-aligned process* where gate blocks n-dopants
- Polysilicon is better than metal for self-aligned gates because it doesn't melt during later processing



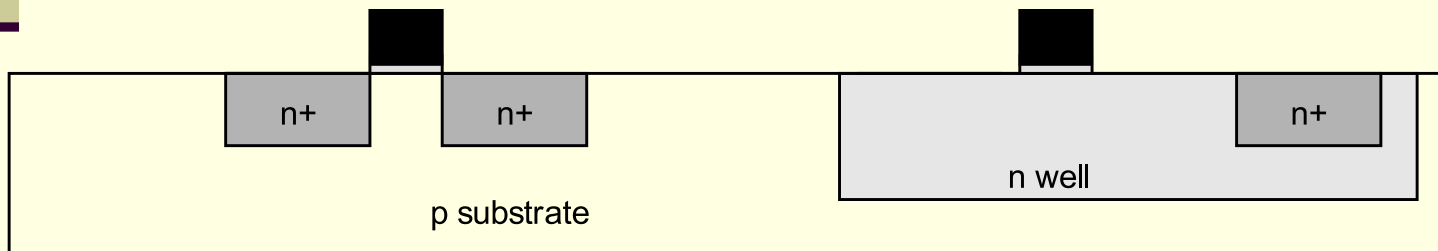
N-diffusion/implantation cont.

- Historically dopants were diffused
- Usually high energy ion-implantation used today
- But n+ regions are still called diffusion



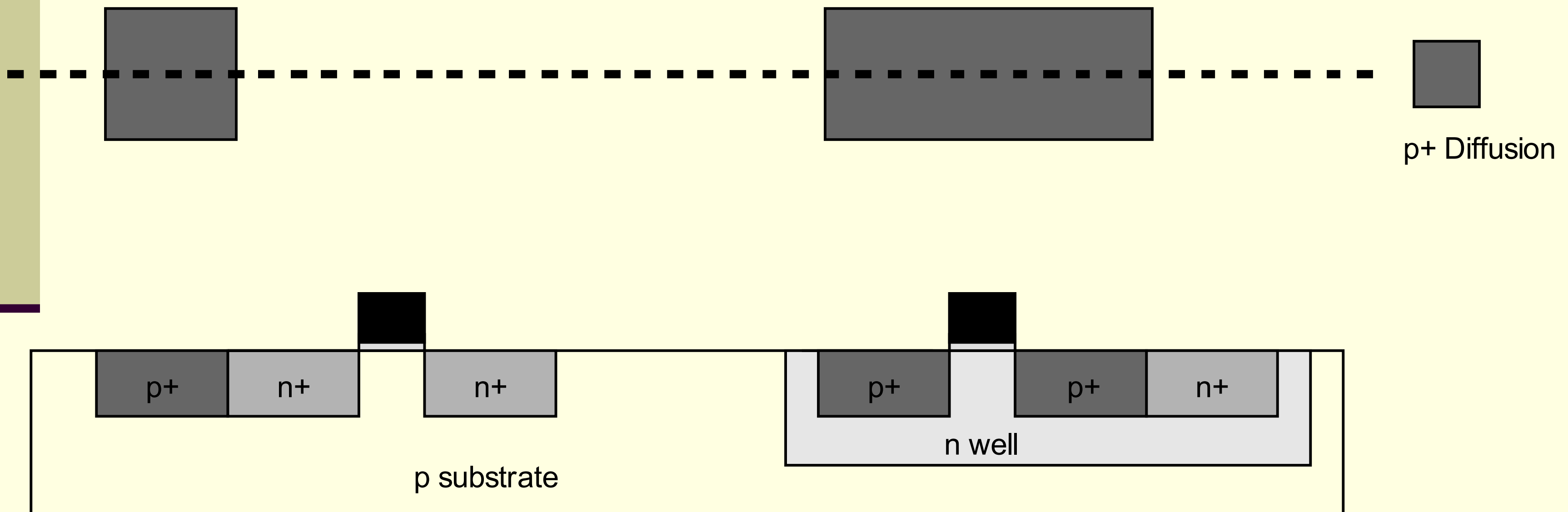
N-diffusion cont.

- Strip off oxide to complete patterning step



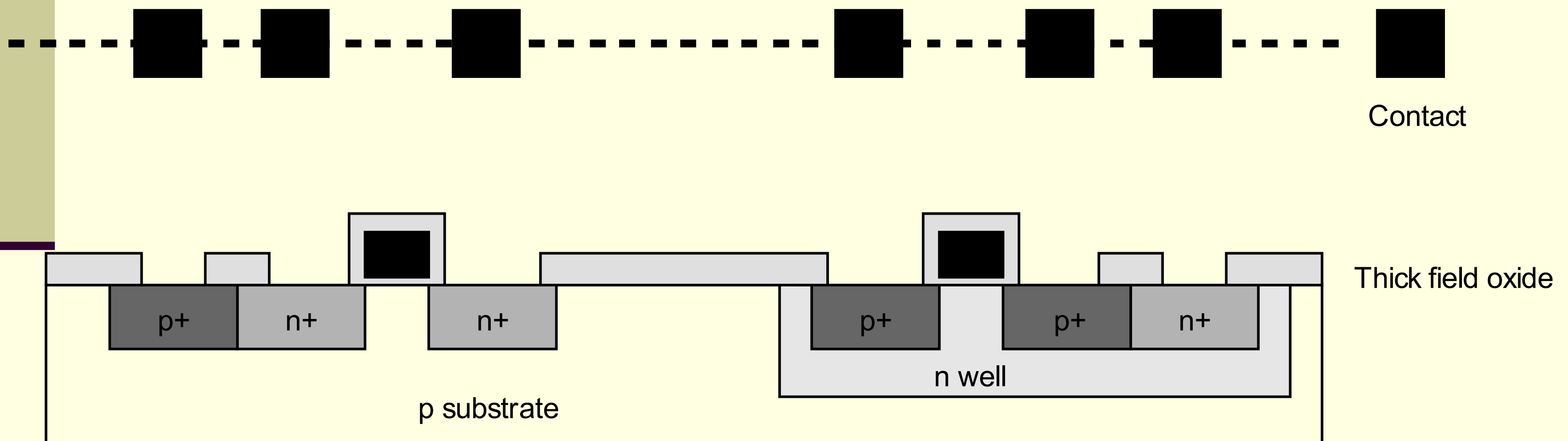
P-Diffusion/implantation

- Similar set of steps form p+ “diffusion” regions for PMOS source and drain and substrate contact



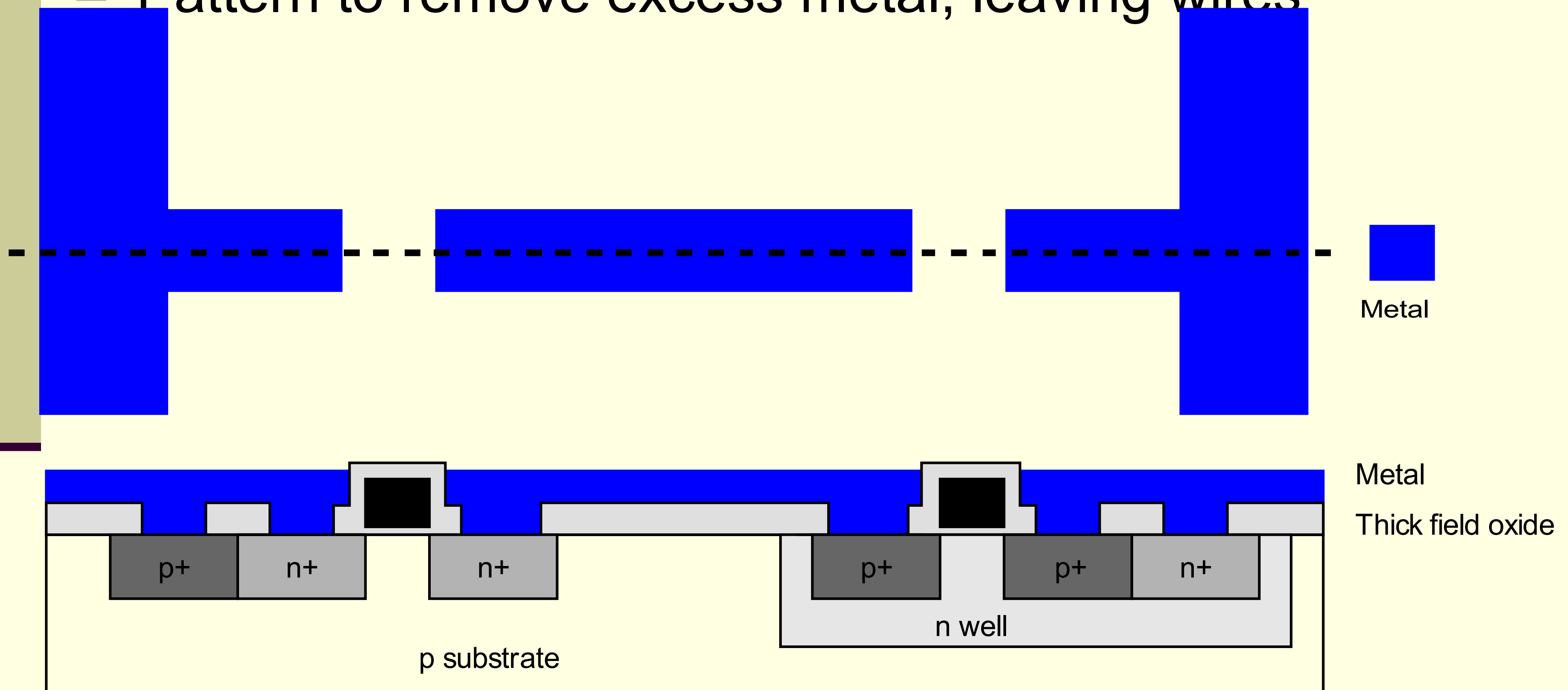
Contacts

- Now we need to wire together the devices
- Cover chip with thick field oxide (FO)
- Etch oxide where contact cuts are needed



Metalization

- Sputter on aluminum over whole wafer
- Copper is used in newer technology
- Pattern to remove excess metal, leaving wires

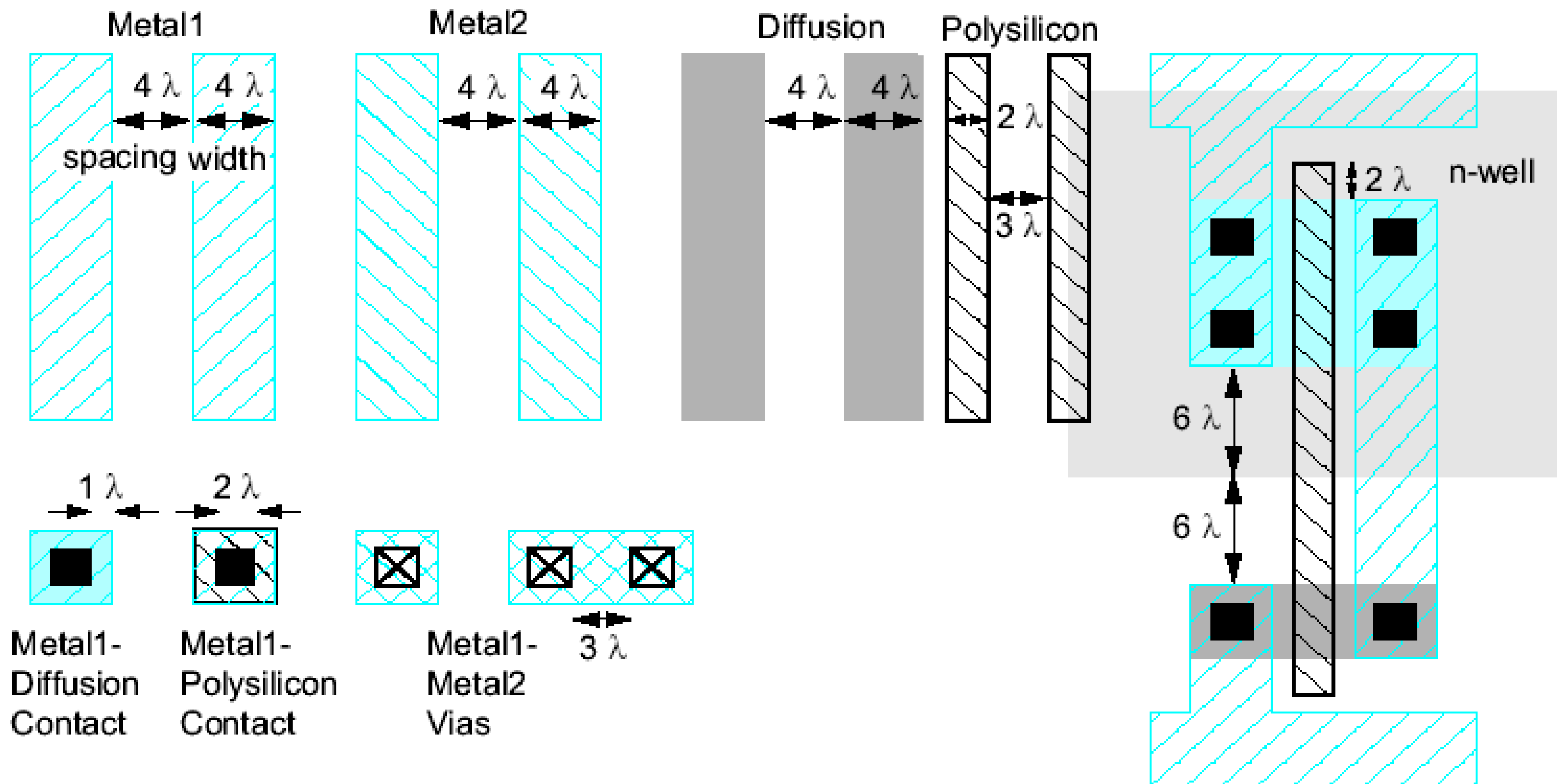


Physical Layout

- Chips are specified with set of masks
- Minimum dimensions of masks determine transistor size (and hence speed, cost, and power)
- Feature size f = distance between source and drain
  - Set by minimum width of polysilicon
- Feature size improves 30% every 3 years or so
- Normalize for feature size when describing design rules
- Express rules in terms of $\lambda = f/2$
  - E.g. $\lambda = 0.3$ μm in 0.6 μm process

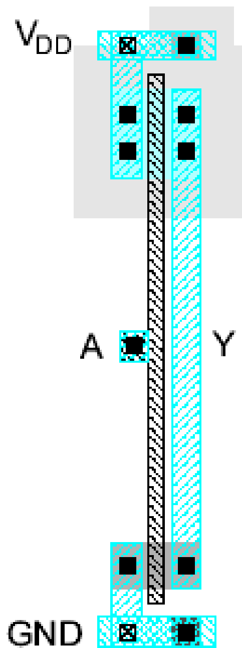
Simplified Design Rules

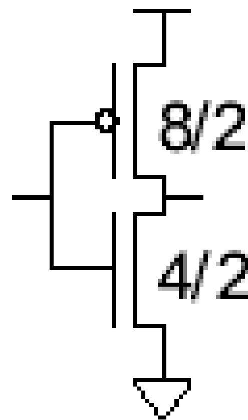
- Conservative rules to get you started

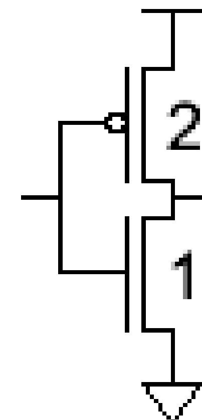


Inverter Layout

- Transistor dimensions specified as Width / Length
  - Minimum size is 4-6λ/ 2λ, sometimes called 1 unit
  - In f = 0.25 μm process, this is 0.5-0.75 μm wide (W), 0.25 μm long (L)
  - Since $\lambda = f/2$, $\lambda = 0.125$ μm.







The Future?
International Technology Roadmap for Semiconductors

Table B ITRS Table Structure—Key Lithography-related Characteristics by Product Type

Near-term Years

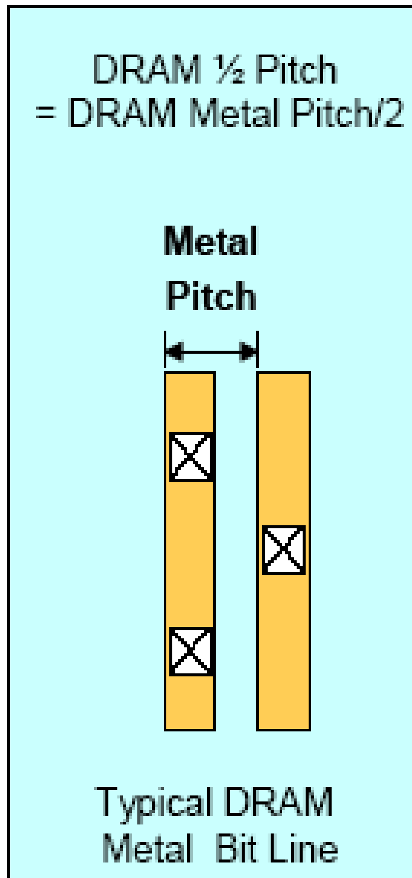
YEAR OF PRODUCTION	2003	2004	2005	2006	2007	2008	2009
Technology Node		hp90			hp65		
DRAM ½ Pitch (nm)	100	90	80	70	65	57	50
MPU/ASIC M1 ½ Pitch (nm)	120	107	95	85	75	67	60
MPU/ASIC Poly Si ½ Pitch (nm)	107	90	80	70	65	57	50
MPU Printed Gate Length (nm)	65	53	45	40	35	32	28
MPU Physical Gate Length (nm)	45	37	32	28	25	22	20

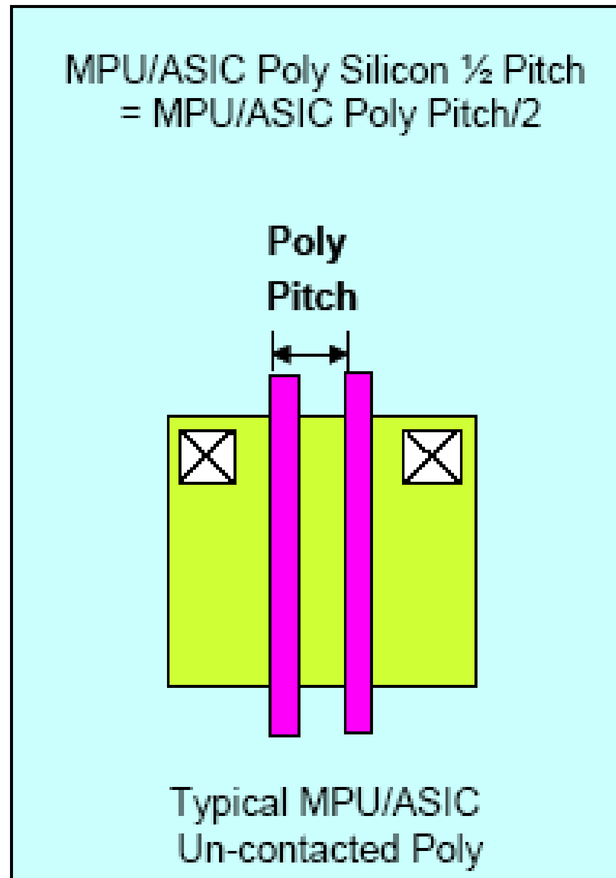
Long-term Years

YEAR OF PRODUCTION	2010	2012	2013	2015	2016	2018
Technology Node	hp45		hp32		hp22	
DRAM ½ Pitch (nm)	45	35	32	25	22	18
MPU/ASIC M1 ½ Pitch (nm)	54	42	38	30	27	21
MPU/ASIC Poly Si ½ Pitch (nm)	45	35	32	25	22	18
MPU Printed Gate Length (nm)	25	20	18	14	13	10
MPU Physical Gate Length (nm)	18	14	13	10	9	7

The ORTC and technology requirements tables are intended to indicate current best estimates of introduction timing for specific technology requirements. Please refer to the Glossary for detailed definitions for Year of Introduction and Year of Production.

http://public.itrs.net/Files/2003ITRS/Home2003.htm





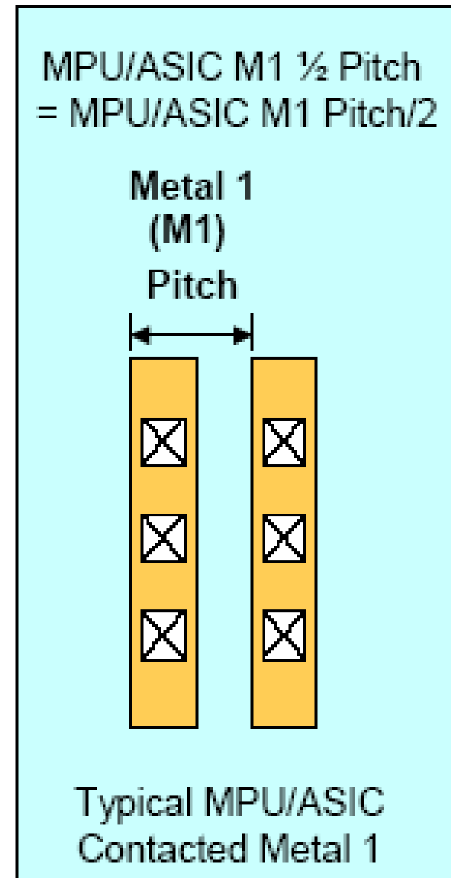


Figure 4 Definition of Metal Half Pitch

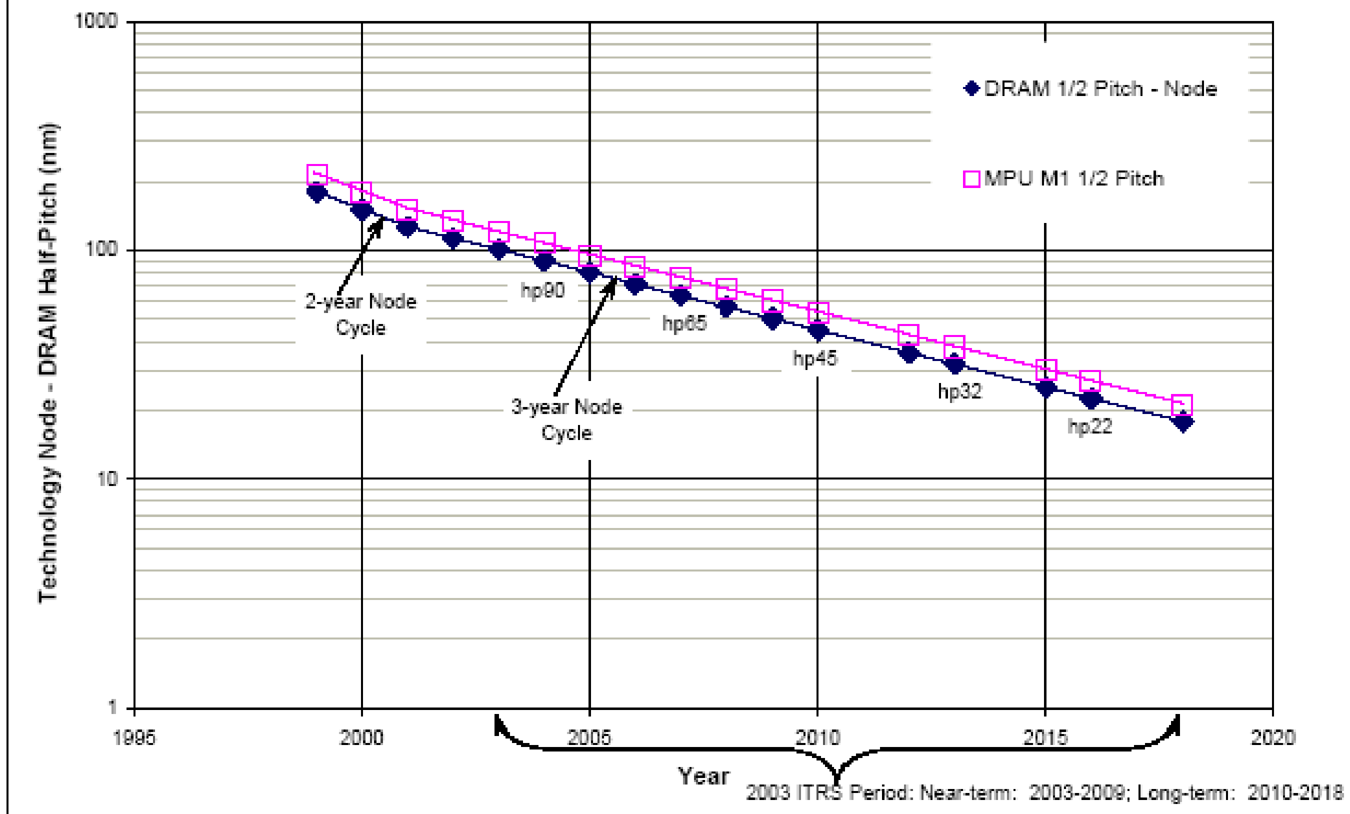


Figure 7 2003 ITRS—Half Pitch Trends

Summary

- MOS Transistors are stack of gate, oxide, silicon

  and p-n junctions
- Can be viewed as electrically controlled switches
- Build logic gates out of switches
- Draw masks to specify layout of transistors
- Now you know everything necessary to start designing schematics and layout for a simple chip!